



Support & training

Texas INSTRUMENTS

ADC3681, ADC3682, ADC3683 ZHCSN12B - DECEMBER 2020 - REVISED OCTOBER 2022

ADC368x 18 位、0.5 至 65MSPS、低噪声、 极低功率双通道 ADC

## 1 特性

- 双通道 ADC ٠
- 18 位 10、25、65MSPS ADC
- 本底噪声:-160dBFS/Hz 低功耗和优化的功率调节:
- 每通道 53mW (10MSPS) 至每通道 94mW (65MSPS)
- 延迟:1-2个时钟周期
- 18 位,无丢码
- INL/DNL: ±7/±0.7LSB(典型值)
- 基准:外部或内部
- 输入带宽: 900 MHz (3dB)
- 工业温度范围:-40°C 至 +105°C
- 片上数字滤波器(可选)
  - 2 倍、4 倍、8 倍、16 倍、32 倍抽取率 - 32 位 NCO
- 串行 LVDS 数字接口 (2 线、1 线和 1/2 线)
- 小尺寸: 40-QFN (5x5mm) 封装
- 频谱性能 (f<sub>IN</sub> = 5MHz):
  - SNR : 83.8dBFS
  - SFDR: 89dBc HD2、HD3
  - SFDR: 101dBFS 最严重毛刺
  - 频谱性能 (f<sub>IN</sub> = 20 MHz):
  - SNR : 82.6dBFS
  - SFDR: 85dBc HD2、HD3
  - SFDR: 97dBFS 最严重毛刺

# 2 应用

- 高速数据采集
- 工业监控
- 软件定义无线电
- 电能质量分析仪
- 源测量单元 (SMU)
- 通信基础设施
- 频谱分析仪
- 控制环路
- 仪表 ٠
- 成像
- 光谱分析 •
- 雷达

# 3 说明

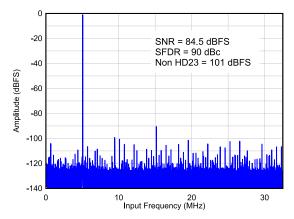
ADC3681、ADC3682、ADC3683 (ADC368x) 属于低 噪声、超低功耗、18 位、65MSPS 高速双通道 ADC 系列器件。该器件可实现超低噪声性能和 -160dBFS/Hz 的噪声频谱密度,还具有出色的线性度 和动态范围。ADC368x 可提供出色的直流精度以及中 频采样支持,因此适合各种应用。高速控制环路受益于 低至仅一个时钟周期的低延迟。该 ADC 在 65Msps 下 的功耗仅为每通道 94mW,且其功耗随采样率减小而 降低。

ADC368x 使用串行 LVDS (SLVDS) 接口输出数据,可 更大限度减少数字互连的次数。该器件提供双通道、单 通道和半通道选项。ADC36xx 属于引脚对引脚兼容 ADC 系列,具有 16 位和 18 位分辨率和不同的速度等 级。它采用 40 引脚 QFN 封装 (5mm x 5mm), 支持 -40°C 至 +105℃ 的工业级工作温度范围。

封装信息				
器件型号	封装 <sup>(1)</sup>	封装尺寸(标称值)		
ADC368x	VQFN (40)	5.00mm x 5.00mm		

(1)如需了解所有可用封装,请参阅数据表末尾的可订购产品附 录。

器件比较				
器件型号	分辨率	采样率		
ADC3683	18 位	65MSPS		
ADC3682	18 位	25MSPS		
ADC3681	18 位	10MSPS		



FFT : Fs = 65MSPS , Fin = 5MHz

本文档旨在为方便起见,提供有关 TI 产品中文版本的信息,以确认产品的概要。有关适用的官方英文版本的最新信息,请访问 www.ti.com,其内容始终优先。TI不保证翻译的准确性和有效性。在实际设计之前,请务必参考最新版本的英文版本。





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**4 Revision History** 注:以前版本的页码可能与当前版本的页码不同

Changes from Revision A (December 2021) to Revision B (October 2022)	Page
• 删除了器件比较表中器件型号 ADC3681 的"产品预发布"说明	
Added the Typical Characteristics - ADC3681 graphs	14
Added the Typical Characteristics - ADC3682 graphs	17
• Added GND symbol to REFGND pin for all voltage reference option diagrams	
Added the Output Bit Mapper section	50
• Added 表 8-11	56
• Changed 图 9-6 diagram with correct indexing	76

CI	hanges from Revision * (December 2020) to Revision A (December 2021)	Page
•	删除了器件比较表中器件型号 ADC3682 的"产品预发布"说明	1
•	Changed Sample N+1 position in 图 7-2 and 图 7-3	28
•	Added condition to resynch during operation to the SYNC section	45



# **5** Pin Configuration and Functions

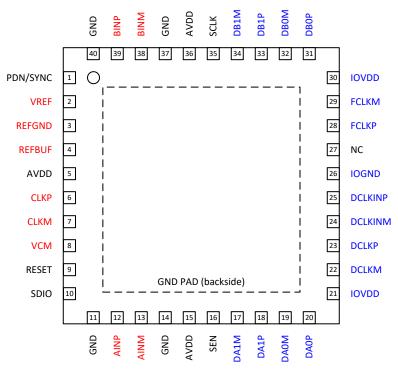


图 5-1. RSB (WQQFN) Package, 40-Pin (Top View)

#### 表 5-1. Pin Descriptions

PIN		· //O	Description			
Name			Description			
INPUT/REFERI	ENCE					
AINP	12	I	Positive analog input, channel A			
AINM	13	I	Negative analog input, channel A			
BINP	39	I	Positive analog input, channel B			
BINM	38	I	Negative analog input, channel B			
VCM	8	0	Common-mode voltage output for the analog inputs, 0.95V			
VREF	2	I	External voltage reference input, 1.6V			
REFBUF	4	I	1.2V external voltage reference input for use with internal reference buffer. Internal 10 pull-up resistor to AVDD. This pin is also used to configure default operating condition			
REFGND	3	I	Reference ground input, 0V			
CLOCK						
CLKP	6	I	Positive differential sampling clock input for the ADC			
CLKM	7	I	Negative differential sampling clock input for the ADC			
CONFIGURATI	ON					
PDN/SYNC	1	I	Power down/Synchronization input. This pin can be configured via the SPI interface. Active high. This pin has an internal 21 k $\Omega$ pull-down resistor.			
RESET	9	I	Hardware reset. Active high. This pin has an internal 21 k $\Omega$ pull-down resistor.			
SEN	16	I	Serial interface enable. Active low. This pin has an internal 21 k $\Omega$ pull-up resistor to AVDD.			
SCLK	35	I	Serial interface clock input. This pin has an internal 21 k $\Omega$ pull-down resistor.			
SDIO	10	I/O	Serial interface data input and output. This pin has an internal 21 k $\Omega$ pull-down resistor.			
NC	27	-	Do not connect			



## 表 5-1. Pin Descriptions (continued)

PIN I/O		1/0	Description	
		1/0	Description	
DIGITAL INT	ERFACE			
DA0P	20	0	Positive differential serial LVDS output for lane 0, channel A	
DA0M	19	0	Negative differential serial LVDS output for lane 0, channel A	
DA1P	18	0	Positive differential serial LVDS output for lane 1, channel A	
DA1M	17	0	Negative differential serial LVDS output for lane 1, channel A	
DB0P	31	0	Positive differential serial LVDS output for lane 0, channel B	
DB0M	32	0	Negative differential serial LVDS output for lane 0, channel B	
DB1P	33	0	Positive differential serial LVDS output for lane 1, channel B	
DB1M	34	0	Negative differential serial LVDS output for lane 1, channel B	
DCLKP	23	0	Positive differential serial LVDS bit clock output.	
DCLKM	22	0	egative differential serial LVDS bit clock output.	
FCLKP	28	0	Positive differential serial LVDS frame clock output.	
FCLKM	29	0	Negative differential serial LVDS frame clock output.	
DCLKINP	25	I	Positive differential serial LVDS bit clock input. Internal 100 $\Omega$ differential termination.	
DCLKINM	24	I	Negative differential serial LVDS bit clock input. Internal 100 $\Omega$ differential termination.	
POWER SUP	PLY			
AVDD	5,15,36	I	Analog 1.8V power supply	
GND	11,14,37,40, PowerPad	Ι	Ground, 0V	
IOVDD	21,30	I	1.8V power supply for digital interface	
IOGND	26	I	Ground, 0V for digital interface	

# **6** Specifications

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT	
Supply voltage range	e, AVDD, IOVDD	- 0.3	- 0.3 2.1		
Supply voltage range	e, GND, IOGND, REFGND	- 0.3	- 0.3 0.3		
	AINP/M, BINP/M, CLKP/M, VREF, REFBUF	- 0.3	MIN(2.1, AVDD+0.3)		
Voltage applied to input pins	PDN/SYNC, RESET, SCLK, SEN, SDIO	- 0.3	MIN(2.1, AVDD+0.3)	V	
input pins	DCLKINP/M	- 0.3	MIN(2.1, IOVDD+0.3)		
Junction temperature	e, T <sub>J</sub>		°C		
Storage temperature	e, T <sub>stg</sub>	- 65	- 65 150		

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 6.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub> Electrostatic discharge		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	2500	V
	) discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	1000	v

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## **6.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply voltage range	AVDD <sup>(1)</sup>	1.75	1.8	1.85	V
	IOVDD <sup>(1)</sup>	1.75	1.8	1.85	V
T <sub>A</sub>	Operating free-air temperature	- 40		105	°C
TJ	Operating junction temperature			105 <mark>(2)</mark>	°C

(1) Measured to GND.

(2) Prolonged use above this junction temperature may increase the device failure-in-time (FIT) rate.

## 6.4 Thermal Information

		ADC368x	
	THERMAL METRIC <sup>(1)</sup>	RSB (QFN)	UNIT
		40 Pins	
R <sub>☉JA</sub>	Junction-to-ambient thermal resistance	30.7	°C/W
R <sub>☉ JC(top)</sub>	Junction-to-case (top) thermal resistance	16.4	°C/W
R <sub>☉ JB</sub>	Junction-to-board thermal resistance	10.5	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	0.2	°C/W
ѰЈВ	Junction-to-board characterization parameter	10.5	°C/W
R <sub>☉JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	2.0	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

### 6.5 Electrical Characteristics - Power Consumption

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, and -1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
ADC3681:	10 MSPS					
I <sub>AVDD</sub>	Analog supply current	External reference		30	46	
IIOVDD	I/O supply current	SLVDS 1-wire		29	46	mA
P <sub>DIS</sub>	Power dissipation	External reference, 1-wire		106	166	mW
		1-wire, 1/2-swing		22		
	I/O supply current	2-wire		36		
IIOVDD		1/2-wire		26		mA
		4x real decimation, 1-wire		30		
		4x real decimation, 1/2-wire		27		
ADC3682:	25 MSPS					
I <sub>AVDD</sub>	Analog supply current	External reference		34	46	
IIOVDD	I/O supply current	1-wire		32	46	mA
P <sub>DIS</sub>	Power dissipation	External reference, 1-wire		119	166	mW
	I/O supply current	1-wire, 1/2-swing		24		
		2-wire		38		
IIOVDD		1/2-wire		28		mA
		4x real decimation, 1-wire		33		
		4x real decimation, 1/2-wire		30		
ADC3683:	65 MSPS					
I <sub>AVDD</sub>	Analog supply current	External reference		63	82	
IIOVDD	I/O supply current	2-wire		41	47	mA
P <sub>DIS</sub>	Power dissipation	External reference, 2-wire		187	232	mW
		2-wire, 1/2-swing		30		
		4x real decimation, 1-wire		39		
		4x real decimation, 1/2-wire		36		
		16x real decimation, 1-wire		37		
IIOVDD	I/O supply current	16x real decimation, 1/2-wire		33		mA
		4x complex decimation, 1-wire		44		
		16x complex decimation, 1-wire		40		
		16x complex decimation, 1/2-wire		36		
MISCELLA	ANEOUS		<u> </u>		I	
	Internal reference, additional analog supply current			3		
I <sub>AVDD</sub>	External 1.2V reference (REFBUF), additional analog supply current			0.3		mA
	Single ended clock input, reduces analog supply current by	Enabled via SPI		0.7		
P	Power consumption in global power	Default mask settings, internal reference		5		mW
P <sub>DIS</sub>	down mode	Default mask settings, external reference		9		IIIVV



# 6.6 Electrical Characteristics - DC Specifications

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, 1.6 V external reference, and - 1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC ACCUR	ACY					
No missing c	codes		18			bits
PSRR		F <sub>IN</sub> = 1 MHz		50		dB
ADC3681: 1	0 MSPS					
DNL	Differential nonlinearity	F <sub>IN</sub> = 5 MHz		± 0.7	± 0.85	LSB
INL	Integral nonlinearity	F <sub>IN</sub> = 5 MHz		± 7	± 16	LSB
V <sub>OS_ERR</sub>	Offset error			± 10	± 410	LSB
V <sub>OS_DRIFT</sub>	Offset drift over temperature			-0.04		LSB/ºC
GAIN <sub>ERR</sub>	Gain error	External 1.6V Reference		0.9		%FSR
GAIN <sub>DRIFT</sub>	Gain drift over temperature	External 1.6V Reference		2		ppm/⁰C
GAIN <sub>ERR</sub>	Gain error	Internal Reference		0.64		%FSR
GAIN <sub>DRIFT</sub>	Gain drift over temperature	Internal Reference		109		ppm/⁰C
Transition No	bise			5		LSB
ADC3682: 2	5 MSPS				I	
DNL	Differential nonlinearity	F <sub>IN</sub> = 5 MHz		± 0.7	± 0.85	LSB
INL	Integral nonlinearity	F <sub>IN</sub> = 5 MHz		± 7	± 16	LSB
V <sub>OS_ERR</sub>	Offset error			± 40	± 410	LSB
V <sub>OS_DRIFT</sub>	Offset drift over temperature			-0.02		LSB/ºC
GAIN <sub>ERR</sub>	Gain error	External 1.6V Reference		0.001		%FSR
GAIN <sub>DRIFT</sub>	Gain drift over temperature	External 1.6V Reference		1.5		ppm/⁰C
GAIN <sub>ERR</sub>	Gain error	Internal Reference		-0.26		%FSR
GAIN <sub>DRIFT</sub>	Gain drift over temperature	Internal Reference		106		ppm/⁰C
Transition No	bise			5		LSB
ADC3683: 6	5 MSPS	I	I			
DNL	Differential nonlinearity	F <sub>IN</sub> = 5 MHz		± 0.7	± 0.9	LSB
INL	Integral nonlinearity	F <sub>IN</sub> = 5 MHz		± 7	± 19	LSB
V <sub>OS_ERR</sub>	Offset error			± 130	± 510	LSB
V <sub>OS_DRIFT</sub>	Offset drift over temperature			± 0.2		LSB/ºC
GAIN <sub>ERR</sub>	Gain error	External 1.6V Reference		± 2.3		%FSR
GAIN <sub>DRIFT</sub>	Gain drift over temperature	External 1.6V Reference		68		ppm/ºC
GAIN <sub>ERR</sub>	Gain error	Internal Reference		± 3.5		%FSR
GAINDRIFT	Gain drift over temperature	Internal Reference		242		ppm/ºC
Transition No	Dise			5		LSB



## 6.6 Electrical Characteristics - DC Specifications (continued)

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, 1.6 V external reference, and -1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	LOG INPUT (AINP/M, BINP/M)					
FS	Input full scale	Differential		3.2		Vpp
V <sub>CM</sub>	Input common model voltage		0.9	0.95	1.0	V
R <sub>IN</sub>	Differential input resistance	F <sub>IN</sub> = 100 kHz		8		kΩ
C <sub>IN</sub>	Differential input Capacitance	F <sub>IN</sub> = 100 kHz		7		pF
V <sub>OCM</sub>	Output common mode voltage			0.95		V
BW	Analog Input Bandwidth (-3dB)			900		MHz
Internal Vo	bltage Reference					
V <sub>REF</sub>	Internal reference voltage			1.6		V
	ut Impedance			8		Ω
	Input Buffer (REFBUF)					
	ference voltage			1.2		V
	oltage reference (VREF)	1			I	
V <sub>REF</sub>	External voltage reference			1.6		V
Input Curre	-			0.3		mA
Input impe				5.3		kΩ
	ut (CLKP/M)					
Input clock	frequency		0.5		65	MHz
V <sub>ID</sub>	Differential input voltage			1	3.6	Vpp
V <sub>CM</sub>	Input common mode voltage			0.9		V
	Single ended input resistance to					
R <sub>IN</sub>	common mode			5		kΩ
C <sub>IN</sub>	Single ended input capacitance			1.5		pF
Clock duty	cycle		40	50	60	%
Digital Inp	uts (RESET, PDN, SCLK, SEN, SDIO)				ŀ	
V <sub>IH</sub>	High level input voltage		1.4			V
V <sub>IL</sub>	Low level input voltage				0.4	V
I <sub>IH</sub>	High level input current			90	150	uA
IIL	Low level input current		-150	-90		uA
CI	Input capacitance			1.5		pF
Digital Ou	tput (SDOUT)				·	
V <sub>OH</sub>	High level output voltage	I <sub>LOAD</sub> = -400 uA	IOVDD - 0.1	IOVDD		V
V <sub>OL</sub>	Low level output voltage	I <sub>LOAD</sub> = 400 uA			0.1	V
SLVDS Int	erface		I		I	
Output data	a rate	per differential SLVDS output pair			1000	Mbps
V <sub>ID</sub>	Differential input voltage		200	350	650	mVpp
V <sub>CM</sub>	Input common mode voltage		1	1.2	1.3	V
V <sub>OD</sub>	Differential output voltage		500	700	850	mVpp
V <sub>CM</sub>	Output common mode voltage			1.0		V



# 6.7 Electrical Characteristics - AC Specifications

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, 1.6 V external reference, and - 1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
ADC3681 - 1	0 MSPS:	-				
NSD	Noise Spectral Density	f <sub>IN</sub> = 1.1 MHz, A <sub>IN</sub> = -20 dBFS		- 151.7		dBFS/Hz
SNR		f <sub>IN</sub> = 1.1 MHz, A <sub>IN</sub> = -20 dBFS		84.7		
	Cirruel to mains write	f <sub>IN</sub> = 1.1 MHz		84.4		dBFS
	Signal to noise ratio	f <sub>IN</sub> = 4.9 MHz	81.5	83.9		
		f <sub>IN</sub> = 9.9 MHz		82.8		dBFS
		f <sub>IN</sub> = 1.1 MHz		84.4		
SINAD	Signal to noise and distortion ratio	f <sub>IN</sub> = 4.9 MHz	80.0	83.9		dBFS
		f <sub>IN</sub> = 9.9 MHz		82.8		
		f <sub>IN</sub> = 1.1 MHz		13.7		
ENOB	Effective number of bits	f <sub>IN</sub> = 4.9 MHz	13.0	13.6		bits
		f <sub>IN</sub> = 9.9 MHz		13.5		
		f <sub>IN</sub> = 1.1 MHz		86		
THD	Total Harmonic Distortion (First five harmonics)	f <sub>IN</sub> = 4.9 MHz	82	86		dBc
	()	f <sub>IN</sub> = 9.9 MHz		83		
	Spur free dynamic range	f <sub>IN</sub> = 1.1 MHz		87		
SFDR	including second and third	f <sub>IN</sub> = 4.9 MHz	82	86		dBc
	harmonic distortion	f <sub>IN</sub> = 9.9 MHz		83		
		f <sub>IN</sub> = 1.1 MHz		100		
Non HD2,3	Spur free dynamic range (excluding HD2 and HD3)	f <sub>IN</sub> = 4.9 MHz	92	98		dBFS
		f <sub>IN</sub> = 9.9 MHz		99		
IMD3	Two tone inter-modulation distortion	$f_1 = 3 \text{ MHz}, f_2 = 4 \text{ MHz}, A_{IN} = -7 \text{ dBFS/tone}$		89		dBc



## 6.7 Electrical Characteristics - AC Specifications (continued)

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, 1.6 V external reference, and -1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
ADC3682 - 2	25 MSPS:					
NSD	Noise Spectral Density	$f_{IN}$ = 1.1 MHz, $A_{IN}$ = -20 dBFS		- 156.1		dBFS/Hz
		f <sub>IN</sub> = 1.1 MHz, A <sub>IN</sub> = - 20 dBFS		85.1		
		f <sub>IN</sub> = 1.1 MHz		84.7		
SNR	Signal to noise ratio	f <sub>IN</sub> = 5 MHz	81.5	84.5		dBFS
		f <sub>IN</sub> = 10 MHz		84.0		
		f <sub>IN</sub> = 20 MHz		82.3		
		f <sub>IN</sub> = 1.1 MHz		84.7		
SINAD	Signal to noise and	f <sub>IN</sub> = 5 MHz	80.0	84.5		dBFS
OINAD	distortion ratio	f <sub>IN</sub> = 10 MHz		84.0		
		f <sub>IN</sub> = 20 MHz		82.3		
	Effective number of bits	f <sub>IN</sub> = 1.1 MHz		13.8		
ENOB		f <sub>IN</sub> = 5 MHz	13.0	13.7		bits
LINOD		f <sub>IN</sub> = 10 MHz		13.7		DIIS
		f <sub>IN</sub> = 20 MHz		13.4		
		f <sub>IN</sub> = 1.1 MHz		85		
THD	Total Harmonic Distortion	f <sub>IN</sub> = 5 MHz	82	89		dBc
	(First five harmonics)	f <sub>IN</sub> = 10 MHz		88		ubc
		f <sub>IN</sub> = 20 MHz		83		
		f <sub>IN</sub> = 1.1 MHz		86		
SFDR	Spur free dynamic range including second and third	f <sub>IN</sub> = 5 MHz	82	90		dBc
OFDIX	harmonic distortion	f <sub>IN</sub> = 10 MHz		89		dDC
		f <sub>IN</sub> = 20 MHz		83		
		f <sub>IN</sub> = 1.1 MHz		102		
Non HD2,3	Spur free dynamic range	f <sub>IN</sub> = 5 MHz	92	101		dBFS
1011102,0	(excluding HD2 and HD3)	f <sub>IN</sub> = 10 MHz		103		
		f <sub>IN</sub> = 20 MHz		100		
IMD3	Two tone inter-modulation	$f_1 = 3 \text{ MHz}, f_2 = 4 \text{ MHz}, A_{IN} = -7 \text{ dBFS/tone}$		84		dBc
	distortion	$f_1$ = 10 MHz, $f_2$ = 12 MHz, $A_{IN}$ = -7 dBFS/tone		87		400



#### 6.7 Electrical Characteristics - AC Specifications (continued)

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, 1.6 V external reference, and -1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
ADC3683 - 6	5 MSPS:						
NSD	Noise Spectral Density	$f_{IN}$ = 1.1 MHz, $A_{IN}$ = -20 dBFS		- 160		dBFS/H	
		f <sub>IN</sub> = 1.1 MHz, A <sub>IN</sub> = - 20 dBFS		84.8			
		f <sub>IN</sub> = 1.1 MHz		84.2			
		f <sub>IN</sub> = 5 MHz	81.0	83.8			
SNR	Signal to noise ratio	f <sub>IN</sub> = 10 MHz		83.6		dBFS	
		f <sub>IN</sub> = 20 MHz		82.6			
		f <sub>IN</sub> = 40 MHz		81.0			
		f <sub>IN</sub> = 70 MHz		77.3			
		f <sub>IN</sub> = 1.1 MHz		80.0			
		f <sub>IN</sub> = 5 MHz		82.7			
0.0.4.5	Signal to noise and	f <sub>IN</sub> = 10 MHz		82.7		1050	
SINAD	distortion ratio	f <sub>IN</sub> = 20 MHz		80.2		dBFS	
		f <sub>IN</sub> = 40 MHz		78.7			
		f <sub>IN</sub> = 70 MHz		75.8			
		f <sub>IN</sub> = 1.1 MHz		13.7			
	Effective number of bits	f <sub>IN</sub> = 5 MHz		13.6			
		f <sub>IN</sub> = 10 MHz		13.6			
ENOB		f <sub>IN</sub> = 20 MHz		13.4		bits	
		f <sub>IN</sub> = 40 MHz		13.2			
		f <sub>IN</sub> = 70 MHz		12.5			
		f <sub>IN</sub> = 1.1 MHz		81			
		f <sub>IN</sub> = 5 MHz	80.5	88			
TUD	Total Harmonic Distortion	f <sub>IN</sub> = 10 MHz		89			
THD	(First five harmonics)	f <sub>IN</sub> = 20 MHz		83		dBc	
		f <sub>IN</sub> = 40 MHz		82			
		f <sub>IN</sub> = 70 MHz		80			
		f <sub>IN</sub> = 1.1 MHz		82			
		f <sub>IN</sub> = 5 MHz	81.5	89			
	Spur free dynamic range	f <sub>IN</sub> = 10 MHz		92			
SFDR	including second and third harmonic distortion	f <sub>IN</sub> = 20 MHz		85		dBc	
		f <sub>IN</sub> = 40 MHz		84			
		f <sub>IN</sub> = 70 MHz		82			
		f <sub>IN</sub> = 1.1 MHz		101			
		f <sub>IN</sub> = 5 MHz	90	101			
	Spur free dynamic range	f <sub>IN</sub> = 10 MHz		100			
Non HD2,3	(excluding HD2 and HD3)	f <sub>IN</sub> = 20 MHz		97		dBFS	
		f <sub>IN</sub> = 40 MHz		91			
		f <sub>IN</sub> = 70 MHz		88			
	Two tone inter-modulation	$f_1 = 10 \text{ MHz}, f_2 = 12 \text{ MHz}, A_{IN} = -7 \text{ dBFS/tone}$		83			
IMD3	distortion	$f_1 = 40$ MHz, $f_2 = 45$ MHz, $A_{IN} = -7$ dBFS/tone		78		dBc	



#### 6.8 Timing Requirements

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, 1.6 V external reference, and - 1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN NOM	MAX	UNIT
ADC Timi	ng Specifications	1			
t <sub>AD</sub>	Aperture Delay		0.85		ns
t <sub>A</sub>	Aperture Jitter	Square wave clock with fast edges	180		fs
tJ	Jitter on DCLKIN			± 50	ps
	Signal acquisition period, referenced to sampling clock falling edge	F <sub>S</sub> = 10 Msps	-T <sub>S</sub> /2		Sampling
t <sub>ACQ</sub>		F <sub>S</sub> = 25 Msps	-T <sub>S</sub> /2		Clock
		F <sub>S</sub> = 65 Msps	-T <sub>S</sub> /4		Period
t <sub>CONV</sub>		F <sub>S</sub> = 10 Msps	+T <sub>S</sub> × 1/5		
	Signal conversion period, referenced to sampling clock falling edge	F <sub>S</sub> = 25 Msps	+T <sub>S</sub> × 3/8		Sampling Clock Period
		F <sub>S</sub> = 65 Msps	+T <sub>S</sub> × 5/8		
	Time to valid data after coming out of power down. Internal reference.	Bandgap reference enabled, single ended clock		17.6	10
		Bandgap reference enabled, differential clock		12.9	us
		Bandgap reference disabled, single ended clock		2.2	ms
Wake up		Bandgap reference disabled, differential clock		2.2	1115
time		Bandgap reference enabled, single ended clock		15.9	us
	Time to valid data after coming out of power down.	Bandgap reference enabled, differential clock		12.9	us
	External 1.6V reference.	Bandgap reference disabled, single ended clock		1.7	ms
		Bandgap reference disabled, differential clock		1.7	1115
t <sub>S,SYNC</sub>	Setup time for SYNC input signal	Referenced to sampling clock rising edge	500		20
t <sub>H,SYNC</sub>	Hold time for SYNC input signal		600		ps
		SLVDS 2-wire	2		ADC
ADC Latency	Signal input to data output	SLVDS 1-wire	1		clock
,		SLVDS 1/2-wire	1		cycles
A .1.1	Real decimation by 2		21		Output
Add Latency	Complex decimation by 2		22		clock
,	Real or complex decimation by 4, 8, 1	6, 32	23		cycles



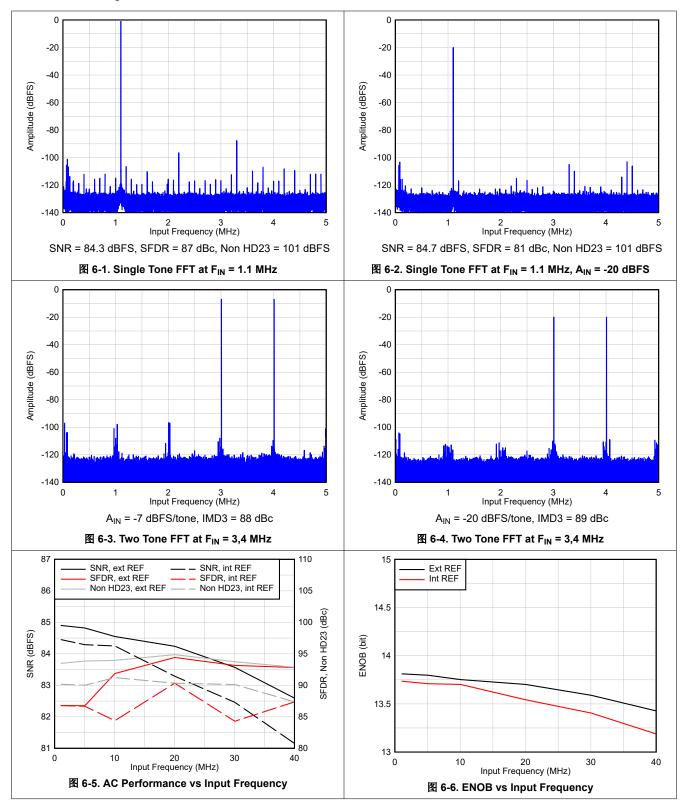
### 6.8 Timing Requirements (continued)

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, 1.6 V external reference, and -1-dBFS differential input, unless otherwise noted

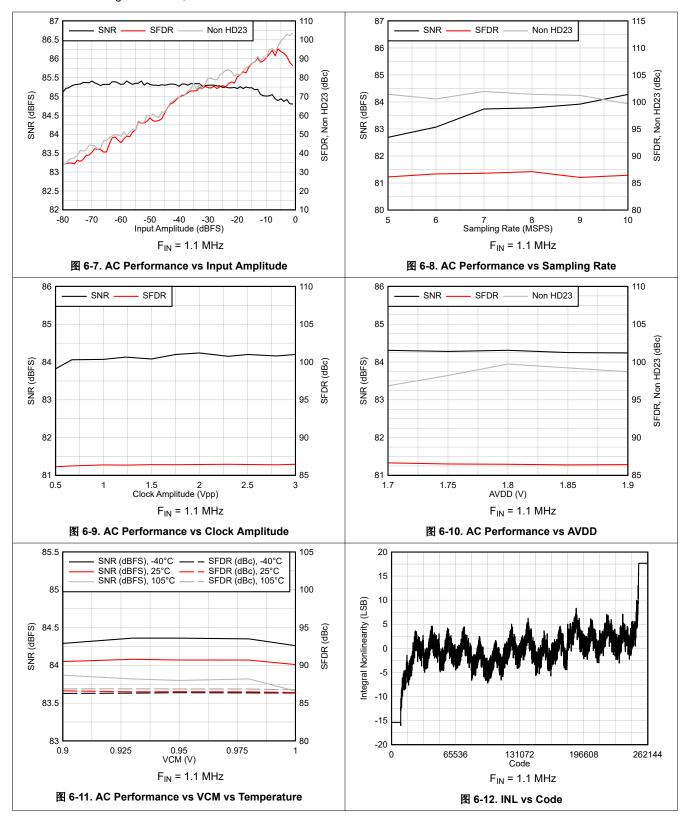
	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
Interface 1	Timing: Serial LVDS Interface					
	Propagation delay: sampling clock	Delay between sampling clock falling edge to DCLKIN falling edge < 2.5ns. $T_{DCLK}$ = DCLK period $t_{CDCLK}$ = Sampling clock falling edge to DCLKIN falling edge	+	3 + T <sub>DCLK</sub> + t <sub>CDCLK</sub>	+	ns
ί <sub>ΡD</sub>		Delay between sampling clock falling edge to DCLKIN falling edge >= 2.5ns. $T_{DCLK}$ = DCLK period $t_{CDCLK}$ = Sampling clock falling edge to DCLKIN falling edge	2 + t <sub>CDCLK</sub>	3 + t <sub>CDCLK</sub>	4 + t <sub>CDCLK</sub>	ns
	DCLK rising edge to output data	Fout = 10 MSPS, DA/B0,1 = 90 MBPS	0	0.1		
	delay,	Fout = 25 MSPS, DA/B0,1 = 225 MBPS	0	0.1		
	2-wire SLVDS	Fout = 65 MSPS, DA/B0,1 = 585 MBPS	0	0.1		
	DCLK rising edge to output data	Fout = 10 MSPS, DA/B0 = 180 MBPS	0.1	0.2		
t <sub>CD</sub>	delay, 1-wire SLVDS	Fout = 25 MSPS, DA/B0 = 450 MBPS	0	0.1		ns
		Fout = 55 MSPS, DA/B0 = 990 MBPS	-0.4	0.1		1
	DCLK rising edge to output data delay, 1/2-wire SLVDS	Fout = 5 MSPS, DA0 = 180 MBPS	0	0.1		
		Fout = 10 MSPS, DA0 = 360 MBPS	0	0.1		
		Fout = 25 MSPS, DA0 = 720 MBPS	0	0.1		
	Data valid, 2-wire SLVDS	Fout = 10 MSPS, DA/B0,1 = 90 MBPS	10.5	10.7		
		Fout = 25 MSPS, DA/B0,1 = 225 MBPS	4.0	4.1		
		Fout = 65 MSPS, DA/B0,1 = 585 MBPS	1.3	1.4		
		Fout = 10 MSPS, DA/B0 = 180 MBPS	4.7	4.8		
t <sub>DV</sub>	Data valid, 1-wire SLVDS	Fout = 25 MSPS, DA/B0 = 450 MBPS	1.8	1.9		ns
		Fout = 55 MSPS, DA/B0 = 990 MBPS	0.5	0.6		
		Fout = 5 MSPS, DA0 = 180 MBPS	4.7	4.8		
	Data valid, 1/2-wire SLVDS	Fout = 10 MSPS, DA0 = 360 MBPS	2.4	2.5		
		Fout = 25 MSPS, DA0 = 900 MBPS	0.6	0.7		
SERIAL PI	ROGRAMMING INTERFACE (SCLK, S	SEN, SDIO) - Input				
f <sub>CLK(SCLK)</sub>	Serial clock frequency				20	MHz
t <sub>SU(SEN)</sub>	SEN to rising edge of SCLK		10			ns
t <sub>H(SEN)</sub>	SEN from rising edge of SCLK		9			ns
t <sub>SU(SDIO)</sub>	SDIO to rising edge of SCLK		17			ns
t <sub>H(SDIO)</sub>	SDIO from rising edge of SCLK		9			ns
SERIAL PI	ROGRAMMING INTERFACE (SDIO) -	Output				
t <sub>(OZD)</sub>	SDIO tri-state to driven		3.9		10.8	ns
t <sub>(ODZ)</sub>	SDIO data to tri-state		3.4		14	ns
t <sub>(OD)</sub>	SDIO valid from falling edge of SCLK		3.9		10.8	ns



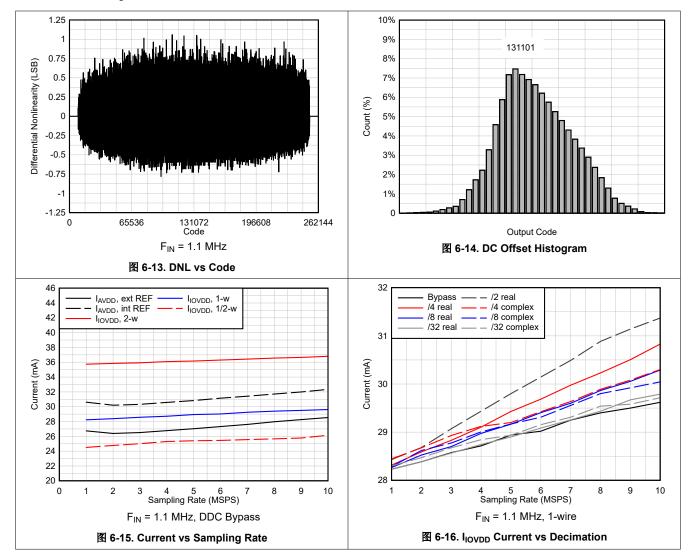
## 6.9 Typical Characteristics - ADC3681





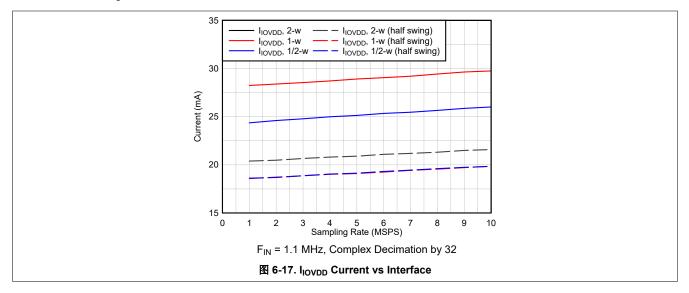




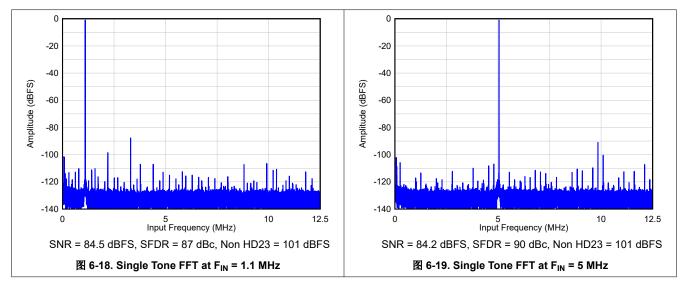




Typical values at  $T_A = 25$  °C, ADC sampling rate = 10 MSPS,  $A_{IN} = -1$  dBFS differential input, AVDD = IOVDD = 1.8 V, external 1.6 V voltage reference, unless otherwise noted.

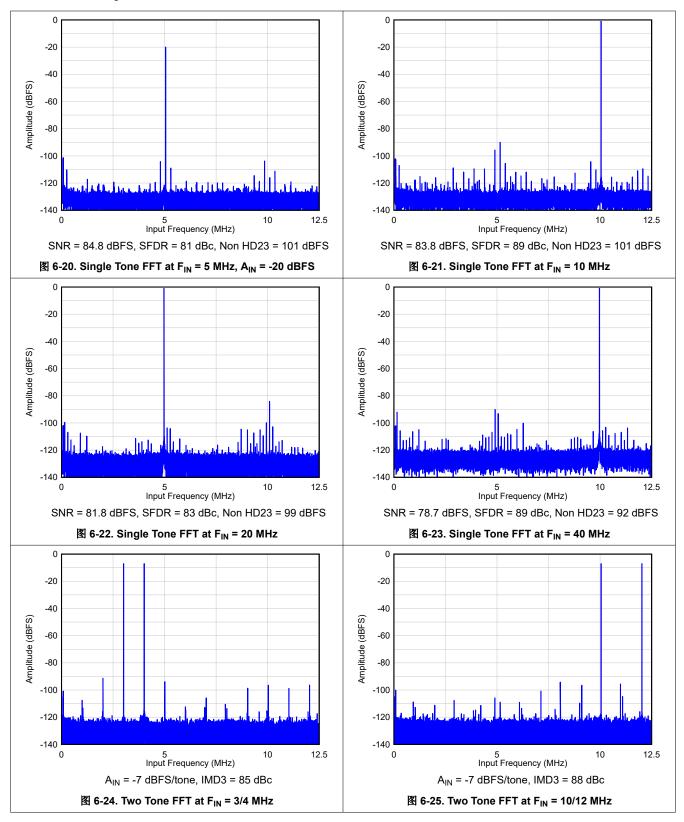


#### 6.10 Typical Characteristics - ADC3682



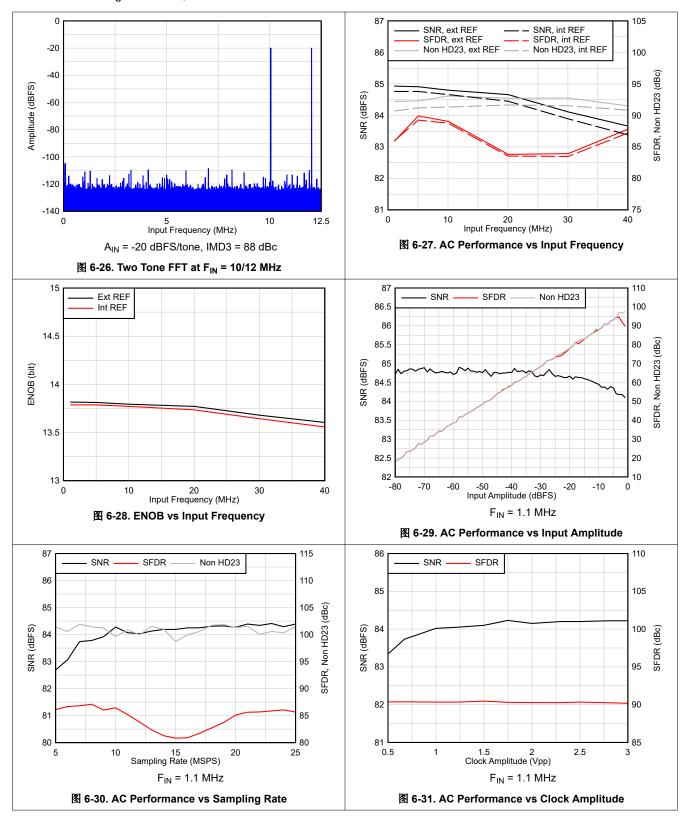


Typical values at  $T_A = 25$  °C, ADC sampling rate = 25 MSPS,  $A_{IN} = -1$  dBFS differential input, AVDD = IOVDD = 1.8 V, external 1.6 V voltage reference, unless otherwise noted.



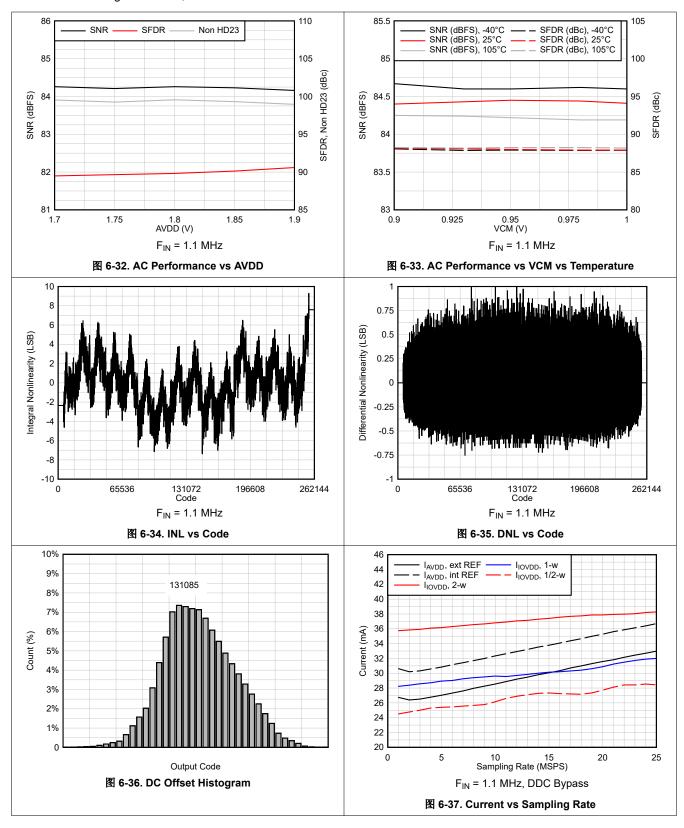
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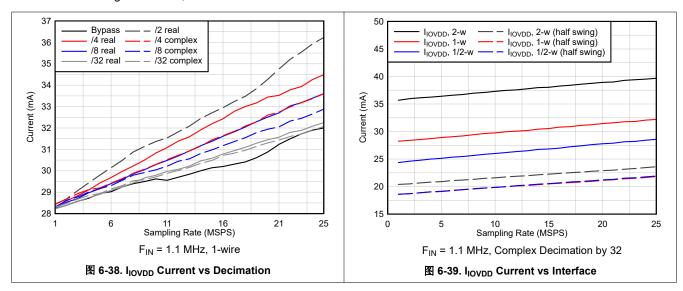


Typical values at  $T_A = 25$  °C, ADC sampling rate = 25 MSPS,  $A_{IN} = -1$  dBFS differential input, AVDD = IOVDD = 1.8 V, external 1.6 V voltage reference, unless otherwise noted.



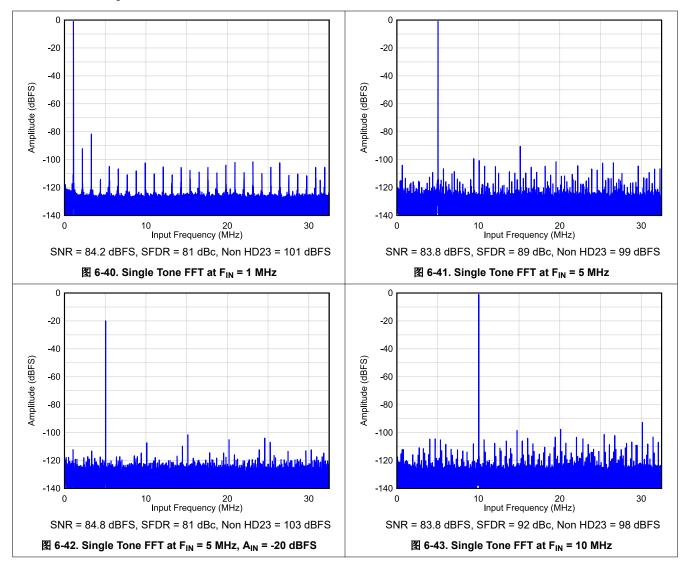
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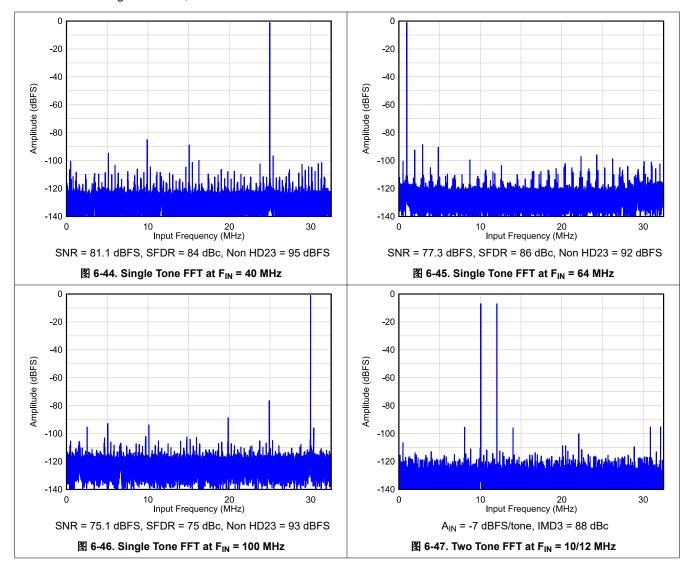


## 6.11 Typical Characteristics - ADC3683

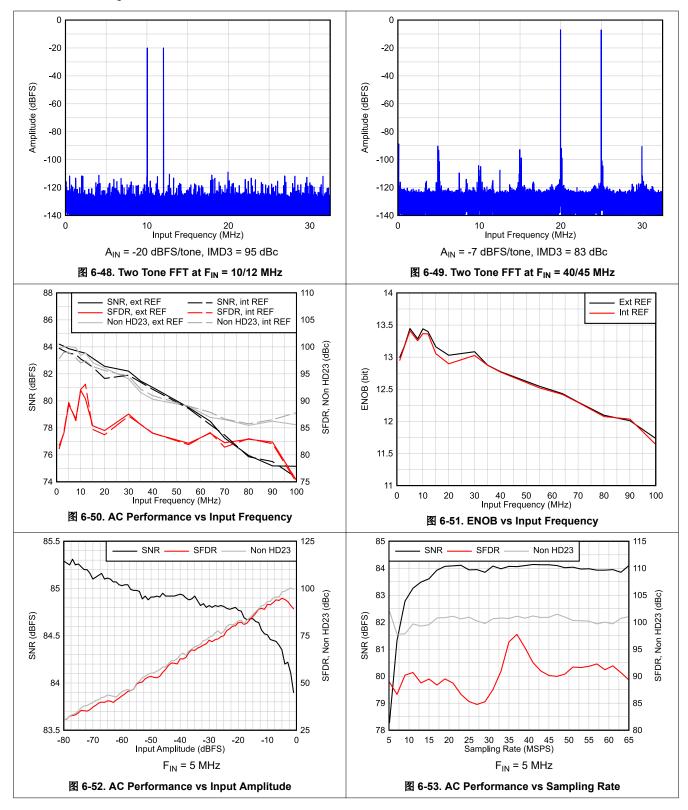




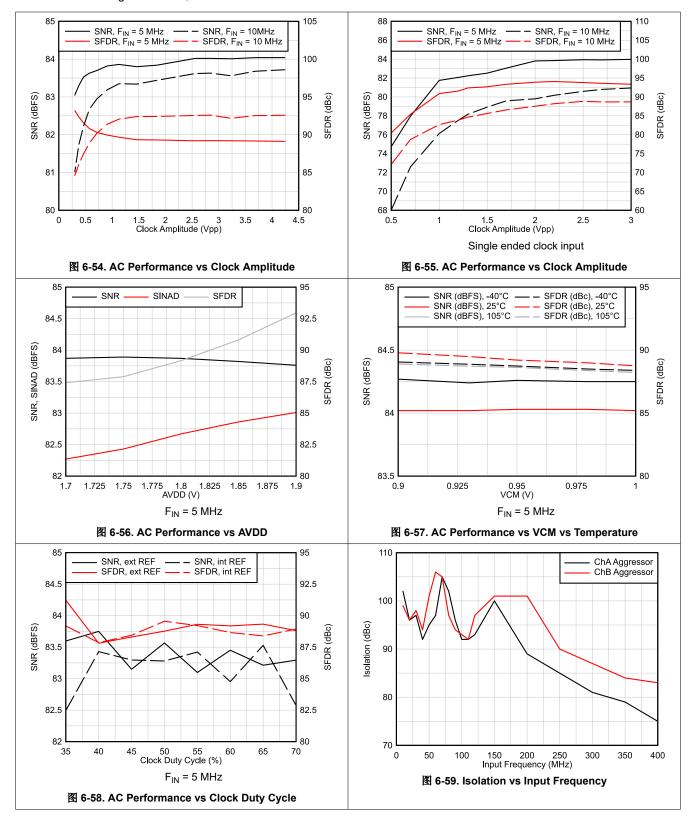




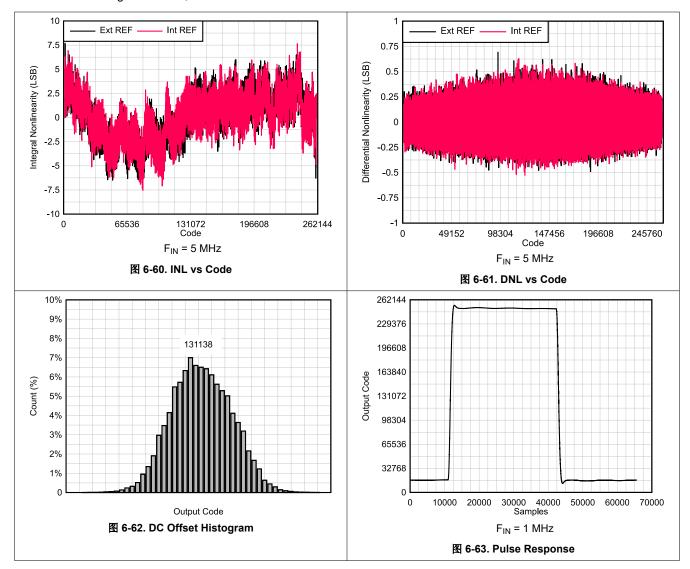




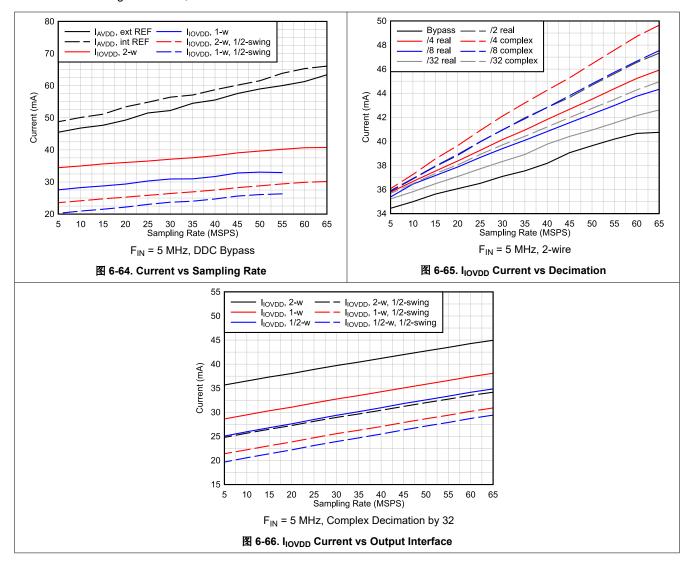














## 7 Parameter Measurement Information

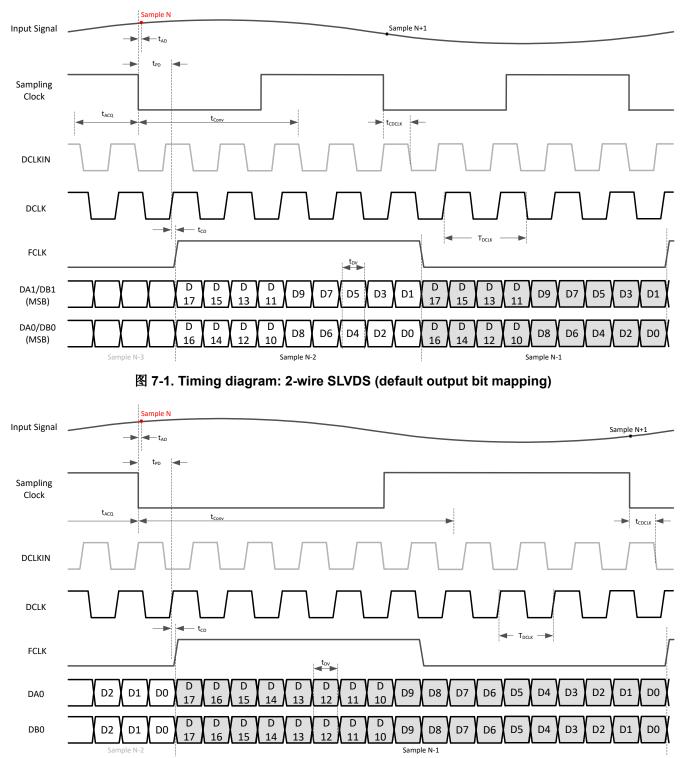


图 7-2. Timing diagram: 1-wire SLVDS (default output bit mapping)



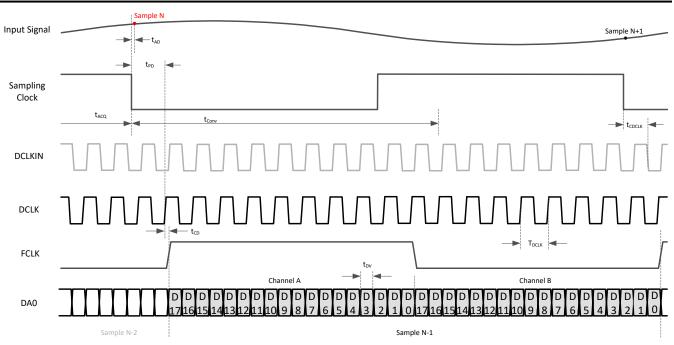


图 7-3. Timing diagram: 1/2-wire SLVDS (default output bit mapping)



# 8 Detailed Description

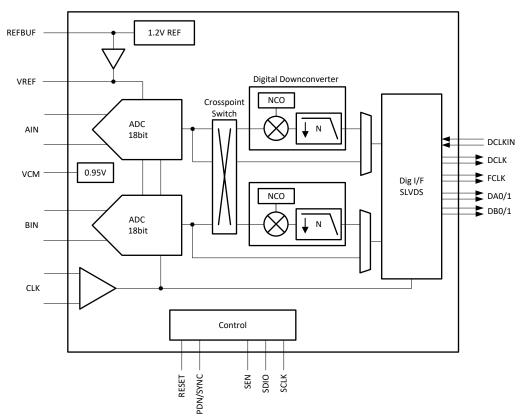
#### 8.1 Overview

The ADC368x is a low noise, ultra-low power 18-bit high-speed dual channel ADC family supporting sampling rates up to 65 MSPS. It offers excellent DC precision together with IF sampling support which makes it ideally suited for a wide range of applications. The ADC368x is equipped with an internal reference option but it also supports the use of an external, high precision 1.6 V voltage reference or an external 1.2 V reference which is buffered and gained up internally. Because of the inherent low latency architecture, the digital output result is available after only one or two clock cycles depending on the digital output interface.

An optional programmable digital down converter enables external anti-alias filter relaxation as well as output data rate reduction. The digital filter provides a 32-bit programmable NCO and supports both real or complex decimation.

The ADC368x uses a serial LVDS (SLVDS) interface to output the data which minimizes the number of digital interconnects. The device supports a two-lane (2-wire), a one-lane (1-wire) and a half-lane (1/2-wire) option. The ADC368x includes a digital output formatter which supports output resolutions from 14 to 20-bit.

The device features and control options can be set up either through pin configurations or via SPI register writes.



#### 8.2 Functional Block Diagram



#### 8.3 Feature Description

#### 8.3.1 Analog Input

The analog inputs of ADC368x are intended to be driven differentially. Both AC coupling and DC coupling of the analog inputs is supported. The analog inputs are designed for an input common mode voltage of 0.95 V which must be provided externally on each input pin. DC-coupled input signals must have a common mode voltage that meets the device input common mode voltage range.

The equivalent input network diagram is shown in 🛛 8-1. All four sampling switches, on-resistance shown in red are in same position (open or closed) simultaneously.

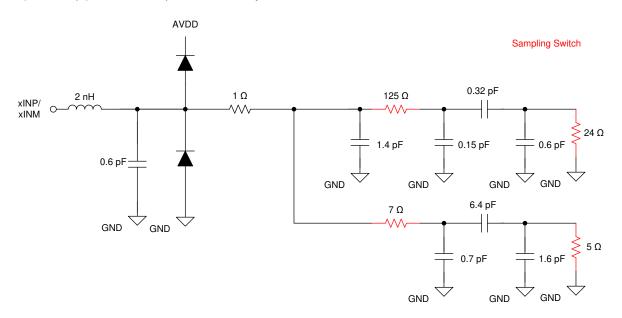
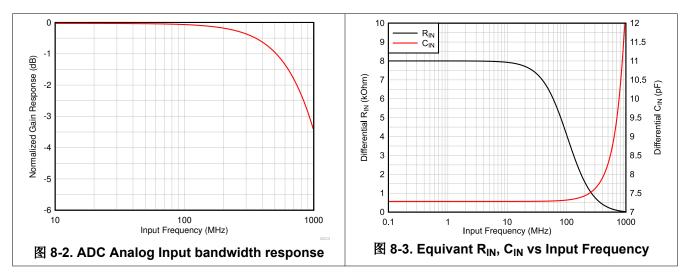


图 8-1. Equivalent input network

#### 8.3.1.1 Analog Input Bandwidth

X 8-2 shows the analog full power input bandwidth of the ADC368x with a 50 Ω differential termination. The -3 dB bandwidth is approximately 900 MHz and the useful input bandwidth with good AC performance is approximately 120 MHz.



The equivalent differential input resistance  $R_{IN}$  and input capacitance  $C_{IN}$  vs frequency are shown in [8] 8-3.



#### 8.3.1.2 Analog Front End Design

The ADC368x is an unbuffered ADC and thus a passive kick-back filter is recommended to absorb the glitch from the sampling operation. Depending on if the input is driven by a balun or a differential amplifier with low output impedance, a termination network may be needed. Additionally a passive DC bias circuit is needed in AC-coupled applications which can be combined with the termination network.

#### 8.3.1.2.1 Sampling Glitch Filter Design

The front end sampling glitch filter is designed to optimize the SNR and HD3 performance of the ADC. The filter performance is dependent on input frequency and therefore the following filter designs are recommended for different input frequency ranges as shown in 8 8-4 and 8 8-5 (assuming a 50  $\Omega$  source impedance).

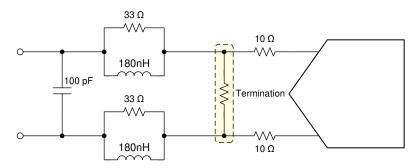


图 8-4. Sampling glitch filter example for input frequencies from DC to 30 MHz

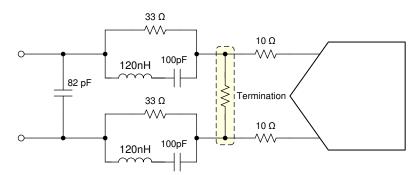


图 8-5. Sampling glitch filter example for input frequencies from 30 to 70 MHz



#### 8.3.1.2.2 Analog Input Termination and DC Bias

Depending on the input drive circuitry, a termination network and/or DC biasing needs to be provided.

#### 8.3.1.2.2.1 AC-Coupling

The ADC368x requires external DC bias using the common mode output voltage (VCM) of the ADC together with the termination network as shown in  $\mathbb{X}$  8-6. The termination is located within the glitch filter network. When using a balun on the input, the termination impedance has to be adjusted to account for the turns ratio of the transformer. When using an amplifier, the termination impedance can be adjusted to optimize the amplifier performance.

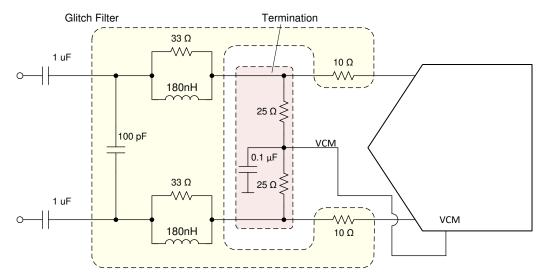
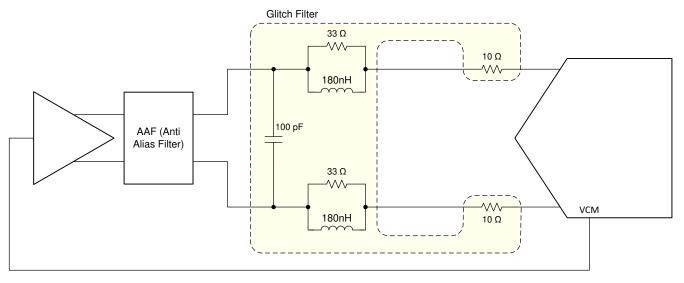


图 8-6. AC-Coupling: termination network provides DC bias (glitch filter example for DC - 30 MHz)

#### 8.3.1.2.2.2 DC-Coupling

In DC coupled applications the DC bias needs to be provided from the fully differential amplifier (FDA) using VCM output of the ADC as shown in 🕅 8-7. The glitch filter in this case is located between the anti-alias filter and the ADC. No termination may be needed if amplifier is located close to the ADC or if the termination is part of the anti-alias filter.

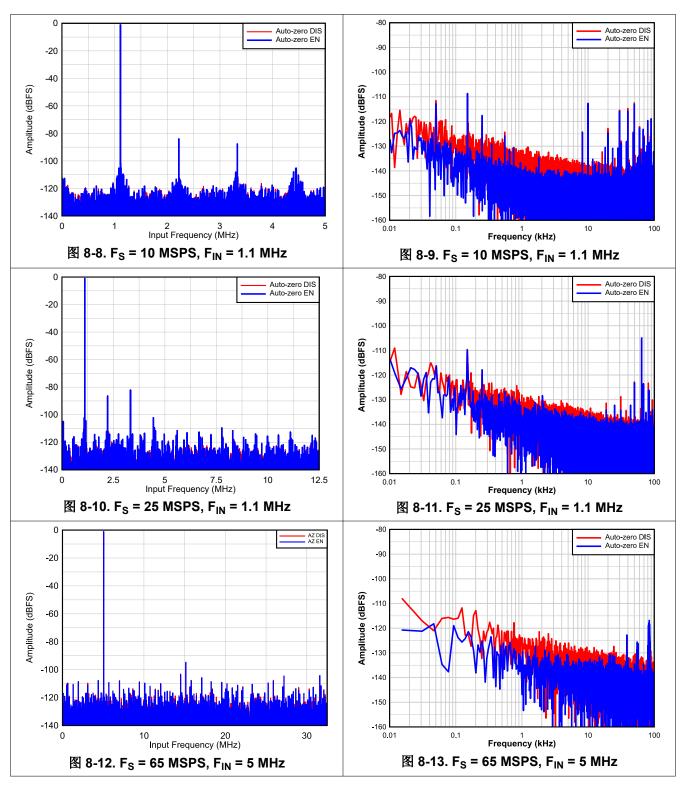






#### 8.3.1.3 Auto-Zero Feature

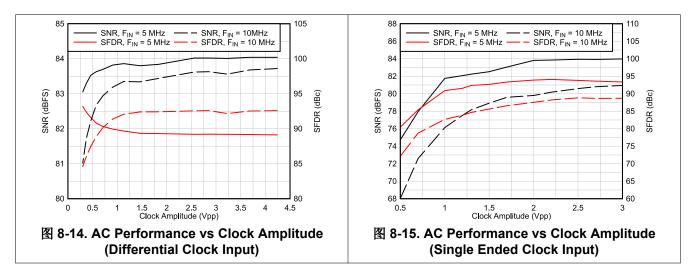
The ADC368x includes an internal auto-zero front end amplifier circuit which improves the 1/f flicker noise. This auto-zero feature is enabled by default for the ADC3681/2 and can be enabled using SPI register writes for the ADC3683 (register 0x11, D0). The 4M point FFTs below show the autozero feature enabled vs disabled.





#### 8.3.2 Clock Input

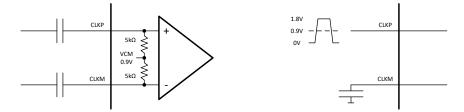
In order to maximize the ADC SNR performance, the external sampling clock should be low jitter and differential signaling with a high slew rate. This is especially important in IF sampling applications ( $\boxtimes$  8-14 and  $\boxtimes$  8-15). For less jitter sensitive applications, the ADC368x provides the option to operate with single ended signaling which saves additional power consumption.



#### 8.3.2.1 Single Ended vs Differential Clock Input

The ADC368x can be operated using a differential or a single ended clock input where the single ended clock consumes less power consumption. However clock amplitude impacts the ADC aperture jitter and consequently the SNR. For maximum SNR performance, a large clock signal with fast slew rates needs to be provided.

- Differential Clock Input: The clock input can be AC coupled externally. The ADC368x provides internal bias.
- Single Ended Clock Input: This mode needs to be configured using SPI register (0x0E, D2 and D0) or with the REFBUF pin. In this mode there is no internal clock biasing and thus the clock input needs to be DC coupled around a 0.9V center. The unused input needs to be AC coupled to ground.



#### 图 8-16. External and internal connection using differential (left) and single ended (right) clock input

#### 8.3.2.2 Signal Acquisition Time Adjust

The ADC368x includes a register (DLL PDN (0x11, D2) which increases the signal acquisition time window for clock rates below 40 MSPS from 25% to 50% of the clock period. Increasing the sampling time provides a longer time for the driving amplifier to settle out the signal which can improve the SNR performance of the system. This register should only be used for the 65 MSPS speed grade (ADC3683) For the 10 and 25 MSPS device speed grades the sampling time is already set to  $T_S/2$ . When powering down the DLL, the acquisition time will track the clock duty cycle (50% is recommended).

SAMPLING CLOCK F <sub>S</sub> (MSPS)	DLL PDN (0x11, D2)	ACQUISITION TIME (t <sub>ACQ</sub> )			
65	0	T <sub>S</sub> / 4			

#### 表 8-1. Acquisition time vs DLL PDN setting



## 表 8-1. Acquisition time vs DLL PDN setting (continued)

SAMPLING CLOCK F <sub>S</sub> (MSPS)	DLL PDN (0x11, D2)	ACQUISITION TIME (t <sub>ACQ</sub> )
≤ 40	1	T <sub>S</sub> / 2



### 8.3.3 Voltage Reference

The ADC368x provides three different options for supplying the voltage reference to the ADC. An external 1.6 V reference can be directly connected to the VREF input; a voltage 1.2 V reference can be connected to the REFBUF input using the internal gain buffer or the internal 1.2 V reference can be enabled to generate a 1.6 V reference voltage. For best performance, the reference noise should be filtered by connecting a 10 uF and a 0.1 uF ceramic bypass capacitor to the VREF pin. The internal reference circuitry of the ADC368x is shown in 8-17.

# 备注

The voltage reference mode can be selected using SPI writes or by using the REFBUF pin (default) as a control pin ( $\ddagger$  8.5.1). If the REFBUF pin is not used for configuration, the REFBUF pin should be connected to AVDD (even though the REFBUF pin has a weak internal pullup to AVDD) and the voltage reference option has to be selected using the SPI interface.

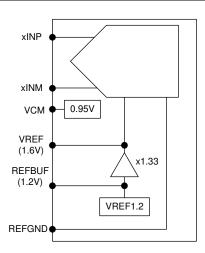


图 8-17. Different voltage reference options for ADC368x

# 8.3.3.1 Internal voltage reference

The 1.6 V reference for the ADC can be generated internal using the on-chip 1.2V bandgap reference along with the internal gain buffer. A 10 uF and a 0.1 uF ceramic bypass capacitor ( $C_{VREF}$ ) should be connected between the VREF and REFGND pins as close to the pins as possible.

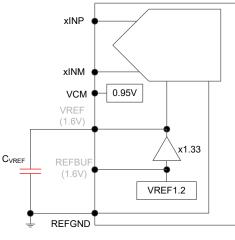


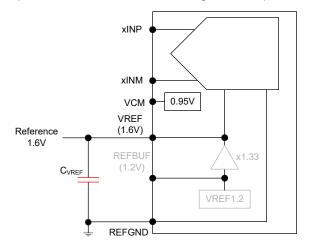
图 8-18. Internal reference



### 8.3.3.2 External voltage reference (VREF)

For highest accuracy and lowest temperature drift, the VREF input can be directly connected to an external 1.6 V reference. A 10 uF and a 0.1 uF ceramic bypass capacitor ( $C_{VREF}$ ) connected between the VREF and REFGND pins and placed as close to the pins as possible is recommended. The load current from the external reference is about 1mA.

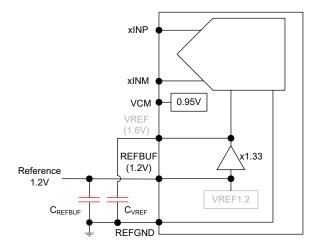
Note: The internal reference is also used for other functions inside the device, therefore the reference amplifier should only be powered down in power down state but not during normal operation.

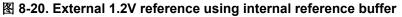




### 8.3.3.3 External voltage reference with internal buffer (REFBUF)

The ADC368x is equipped with an on-chip reference buffer that also includes gain to generate the 1.6 V reference voltage from an external 1.2V reference. A 10 uF and a 0.1 uF ceramic bypass capacitor ( $C_{VREF}$ ) between the VREF and REFGND pins and a 10 uF and a 0.1 uF ceramic bypass capacitor between the REFBUF and REFGND pins are recommended. Both capacitors should be placed as close to the pins as possible. The load current from the external reference is less than 100uA.







# 8.3.4 Digital Down Converter

The ADC368x includes an optional on-chip digital down conversion (DDC) decimation filter that can be enabled via SPI register settings. It supports complex decimation by 2, 4, 8, 16 and 32 using a digital mixer and a 32-bit numerically controlled oscillator (NCO) as shown in 🔀 8-21.

Furthermore it supports a mode with real decimation where the complex mixer is bypassed (NCO should be set to 0 for lowest power consumption) and the digital filter acts as a low pass filter.

Internally the decimation filter calculations are performed with a 20-bit resolution in order to avoid any SNR degradation due to quantization noise limitation. The  $\ddagger$  8.3.5.1 truncates to the selected resolution prior to outputting the data on the digital interface.

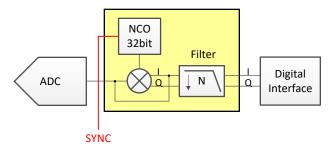


图 8-21. Internal Digital Decimation Filter

### 8.3.4.1 DDC MUX

The ADC368x contains a MUX in front of the digital decimation filter which allows ADC ChA to be connected to DDC ChB and vice versa. This feature is enabled and controlled using the SPI interface. Subsequently the output interface corresponds to the DDC channel A and B.

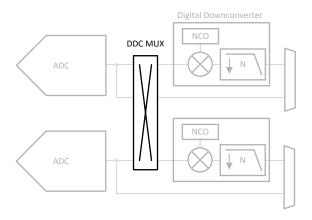
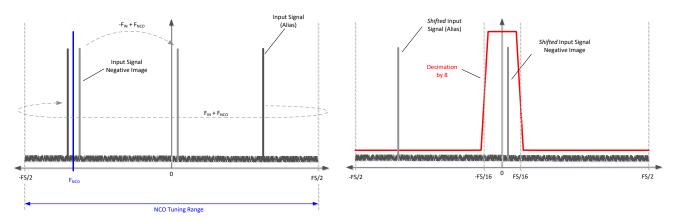


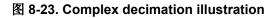
图 8-22. DDC MUX



### 8.3.4.2 Digital Filter Operation

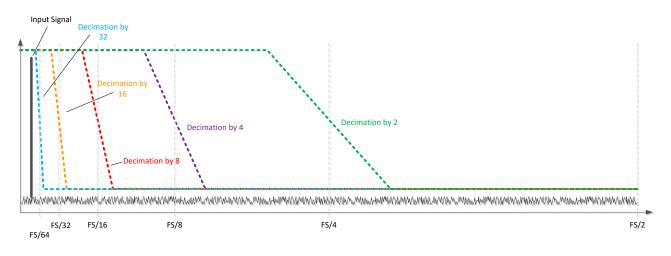
The complex decimation operation is illustrated with an example in  $\mathbb{X}$  8-23. First the input signal (and the negative image) are frequency shifted by the NCO frequency as shown on the left. Next a digital filter is applied (centered around 0 Hz) and the output data rate is decimated by 8 complex - in this example the output data rate  $F_{S,OUT} = F_S/8$  with a Nyquist zone of  $F_S/16$ . During the complex mixing the spectrum (signal and noise) is split into real and complex parts and thus the amplitude is reduced by 6-dB. In order to compensate this loss, there is a 6-dB digital gain option in the decimation filter block that can be enabled via SPI write.





The real decimation operation is illustrated with an example in  $\mathbb{X}$  8-24. There is no frequency shift happening and only the real portion of the complex digital filter is exercised. The output data rate is decimated - a decimation of 8 would result in an output data rate  $F_{S,OUT} = F_S/8$  with a Nyquist zone of  $F_S/16$ .

During the real mixing the spectrum (signal and noise) amplitude is reduced by 3-dB. In order to compensate this loss, there is a 3-dB digital gain option in the decimation filter block that can be enabled via SPI write.







# 8.3.4.3 FS/4 Mixing with Real Output

In this mode, the output after complex decimation gets mixed with FS/4 (FS = output data rate in this case). Instead of a complex output with the input signal centered around 0 Hz, the output is transmitted as a real output at twice the data rate and the signal is centered around FS/4 (Fout/4) as illustrated in 🛽 8-25.

In this example, complex decimation by 8 is used. The output data is transmitted as a real output with an output rate of Fout = FS'/4 (FS' = ADC sampling rate). The input signal is now centered around FS/4 (Fout/4) or FS'/16.

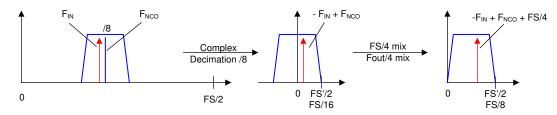


图 8-25. FS/4 Mixing with real output

### 8.3.4.4 Numerically Controlled Oscillator (NCO) and Digital Mixer

The decimation block is equipped with a 32-bit NCO and a digital mixer to fine tune the frequency placement prior to the digital filtering. The oscillator generates a complex exponential sequence of:

(1)

where: frequency ( $\omega$ ) is specified as a signed number by the 32-bit register setting

The complex exponential sequence is multiplied with the real input from the ADC to mix the desired carrier to a frequency equal to  $f_{IN}$  +  $f_{NCO}$ . The NCO frequency can be tuned from  $-F_S/2$  to  $+F_S/2$  and is processed as a signed, 2s complement number. After programming a new NCO frequency, the MIXER RESTART register bit or SYNC pin has to be toggled for the new frequency to get active. Additionally the ADC368x provides the option via SPI to invert the mixer phase.

The NCO frequency setting is set by the 32-bit register value given and calculated as:

NCO frequency = 0 to +  $F_S/2$ : NCO =  $f_{NCO} \times 2^{32} / F_S$ 

NCO frequency =  $-F_S/2$  to 0: NCO =  $(f_{NCO} + F_S) \times 2^{32} / F_S$ 

where:

- NCO = NCO register setting (decimal value)
- f<sub>NCO</sub> = Desired NCO frequency (MHz)
- F<sub>S</sub> = ADC sampling rate (MSPS)

The NCO programming is further illustrated with this example:

- ADC sampling rate F<sub>S</sub> = 65 MSPS
- Input signal f<sub>IN</sub> = 10 MHz
- Desired output frequency  $f_{OUT} = 0 \text{ MHz}$

For this example there are actually four ways to program the NCO and achieve the desired output frequency as shown in 表 8-2.

₹ 6-2. NOO value calculations example										
Alias or negative image	f <sub>NCO</sub>	NCO Value	Mixer Phase	Frequency translation for f <sub>OUT</sub>						
f <sub>IN</sub> = - 10 MHz	f <sub>NCO</sub> = 10 MHz	660764199	as is	$f_{OUT} = f_{IN} + f_{NCO} = -10 \text{ MHz} + 10 \text{ MHz} = 0 \text{ MHz}$						
f <sub>IN</sub> = 10 MHz	f <sub>NCO</sub> = - 10 MHz	3634203097	as 15	$f_{OUT} = f_{IN} + f_{NCO} = 10 \text{ MHz} + (-10 \text{ MHz}) = 0 \text{ MHz}$						

表 8-2	. NCO	value	calculations	example
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$\approx$ 8-2. NCO value calculations example (continued)										
Alias or negative image	f <sub>NCO</sub> NCO Value		Mixer Phase	Frequency translation for f <sub>OUT</sub>						
f <sub>IN</sub> = 10 MHz	f <sub>NCO</sub> = 10 MHz	660764199		$f_{OUT} = f_{IN} - f_{NCO} = 10 \text{ MHz} - 10 \text{ MHz} = 0 \text{ MHz}$						
f <sub>IN</sub> = - 10 MHz	f <sub>NCO</sub> = − 10 MHz	3634203097	inverted	$f_{OUT} = f_{IN} - f_{NCO} = -10 \text{ MHz} - (-10 \text{ MHz}) = 0 \text{ MHz}$						

# 表 8-2. NCO value calculations example (continued)



# 8.3.4.5 Decimation Filter

The ADC368x supports complex decimation by 2, 4, 8, 16 and 32 with a stopband rejection of at least 85 dB and a pass-band bandwidth of ~ 80%.  $\gtrsim$  8-3 gives an overview of the pass-band bandwidth of the different decimation settings with respect to ADC sampling rate F<sub>S</sub>. In real decimation mode the output bandwidth is half of the complex bandwidth.

REAL/COMPLEX DECIMATION	DECIMATION SETTING N	OUTPUT RATE	OUTPUT BANDWIDTH	OUTPUT RATE (F <sub>S</sub> = 65 MSPS)	OUTPUT BANDWIDTH (F <sub>S</sub> = 65 MSPS)
	2	F <sub>S</sub> / 2 complex	0.8 × F <sub>S</sub> / 2	32.5 MSPS complex	26 MHz
	4	F <sub>S</sub> / 4 complex	0.8 × F <sub>S</sub> / 4	16.25 MSPS complex	13 MHz
Complex	8	F <sub>S</sub> / 8 complex	0.8 × F <sub>S</sub> / 8	8.125 MSPS complex	6.5 MHz
	16	F <sub>S</sub> / 16 complex	0.8 × F <sub>S</sub> / 16	4.0625 MSPS complex	3.25 MHz
	32	F <sub>S</sub> / 32 complex	0.8 × F <sub>S</sub> / 32	2.03125 MSPS complex	1.625 MHz
	2	F <sub>S</sub> / 2 real	0.4 × F <sub>S</sub> / 2	32.5 MSPS	13 MHz
	4	F <sub>S</sub> / 4 real	0.4 × F <sub>S</sub> / 4	16.25 MSPS	6.5 MHz
Real	8	F <sub>S</sub> / 8 real	0.4 × F <sub>S</sub> / 8	8.125 MSPS	3.25 MHz
	16	F <sub>S</sub> / 16 real	0.4 × F <sub>S</sub> / 16	4.0625 MSPS	1.625 MHz
	32	F <sub>S</sub> / 32 real	0.4 × F <sub>S</sub> / 32	2.03125 MSPS	0.8125 MHz

#### 表 8-3. Decimation Filter Summary and Maximum Available Output Bandwidth

The decimation filter responses are normalized to the ADC sampling clock frequency  $F_S$  and illustrated in  $\boxtimes$  8-27 to  $\boxtimes$  8-36. They are interpreted as follows:

Each figure contains the filter pass-band, transition band(s) and alias or stop-band(s) as shown in  $\mathbb{E}$  8-26. The x-axis shows the offset frequency (after the NCO frequency shift) normalized to the ADC sampling rate F<sub>S</sub>.

For example, in the divide-by-4 complex setup, the output data rate is  $F_S / 4$  complex with a Nyquist zone of  $F_S / 8$  or  $0.125 \times F_S$ . The transition band (colored in blue) is centered around  $0.125 \times F_S$  and the alias transition band is centered at  $0.375 \times F_S$ . The stop-bands (colored in red), which alias on top of the pass-band, are centered at  $0.25 \times F_S$  and  $0.5 \times F_S$ . The stop-band attenuation is greater than 85 dB.

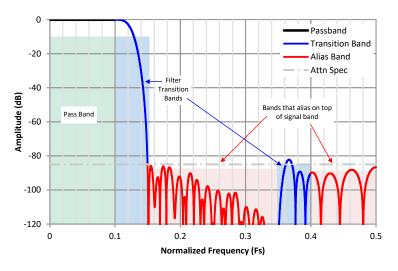
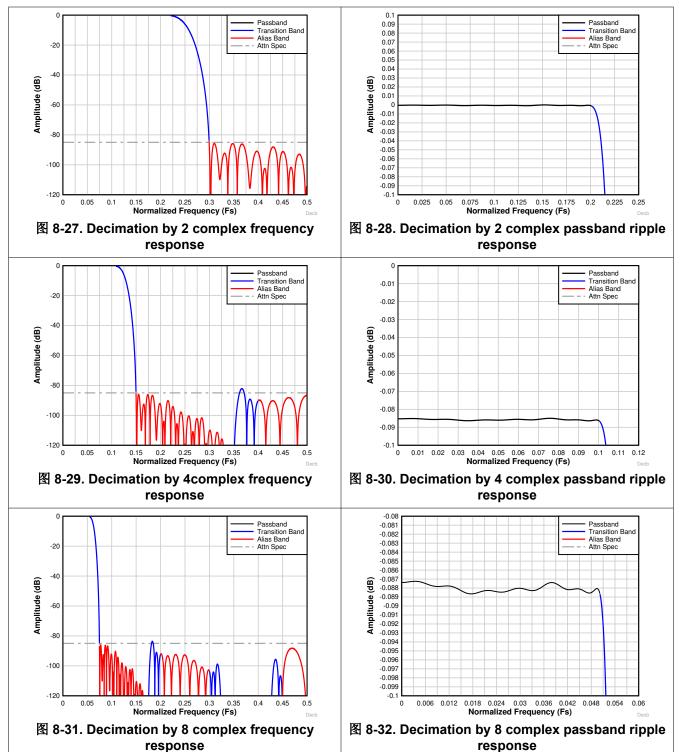
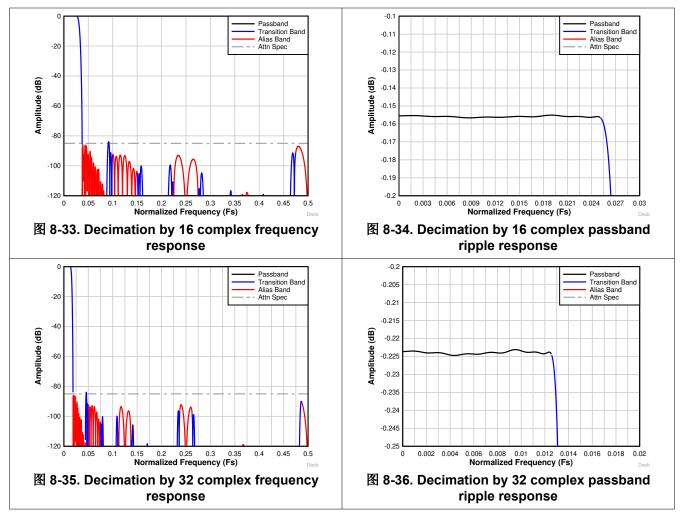


图 8-26. Interpretation of the Decimation Filter Plots









# 8.3.4.6 SYNC

The PDN/SYNC pin can be used to synchronize multiple devices using an external SYNC signal. The PDN/ SYNC pin can be configured via SPI (SYNC EN bit) from power down to synchronization functionality and is latched in by the rising edge of the sampling clock as shown in 🕅 8-37.

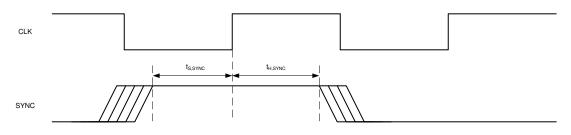


图 8-37. External SYNC timing diagram

The synchronization signal is only required when using the decimation filter - either using the SPI SYNC register or the PDN/SYNC pin. It resets internal clock dividers used in the decimation filter and aligns the internal clocks as well as I and Q data within the same sample. If no SYNC signal is given, the internal clock dividers is not be synchronized, which can lead to a fractional delay across different devices. The SYNC signal also resets the NCO phase and loads the new NCO frequency (same as the MIXER RESTART bit).

When trying to resynchronize during operation, the SYNC toggle should occur at 64\*K clock cycles, where K is an integer. This provids the phase continuity of the clock divider.

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### 8.3.4.7 Output Formatting with Decimation

When using decimation, the digital output data is formatted as shown in 🖄 8-38 (complex decimation) and 🕅 8-39 (real decimation). The output format is illustrated for 18-bit output resolution.

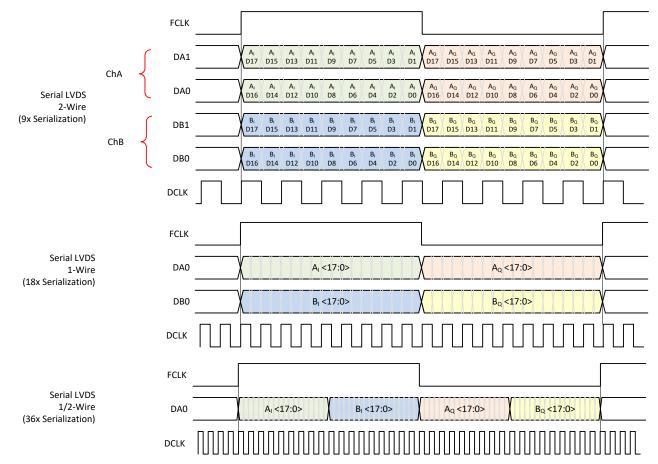


图 8-38. Output Data Format in Complex Decimation (18-bit Output Resolution)

**8**-4 illustrates the output interface data rate along with the corresponding DCLK/DCLKIN and FCLK frequencies based on output resolution (R), number of SLVDS lanes (L) and complex decimation setting (N).

Furthermore the table shows an actual lane rate example for the 2-, 1- and 1/2-wire interface, 18-bit output resolution and complex decimation by 4.

DECIMATION SETTING	ADC SAMPLING RATE	OUTPUT RESOLUTION	# of WIRES	FCLK	DCLKIN, DCLK	DA/B0,1
N	F <sub>S</sub>	R	L	F <sub>S</sub> / N	[DA/B0,1] / 2	F <sub>S</sub> x2xR/L/N
	65 MSPS		2	16.25 MHz	146.25 MHz	292.5 MHz
4		18	1	10.23 10112	292.5 MHz	585 MHz
	55 MSPS		1/2	13.75 MHz	495 MHz	990 MHz



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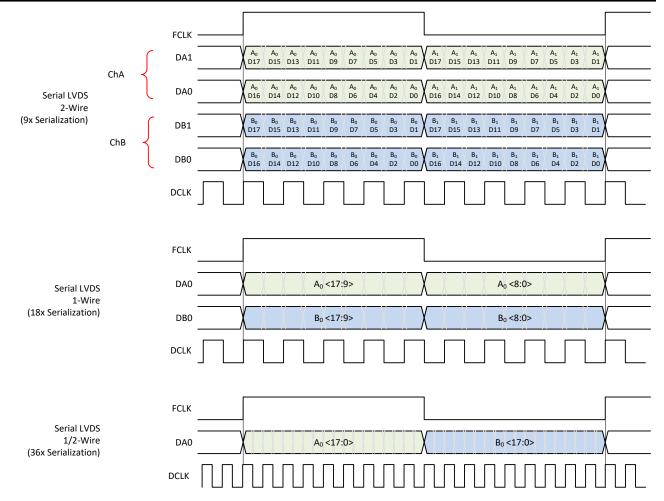


图 8-39. Output Data Format in Real Decimation (18-bit Output Resolution)

表 8-5 illustrates the output interface data rate along with the corresponding DCLK/DCLKIN and FCLK frequencies based on output resolution (R), number of SLVDS lanes (L) and real decimation setting (M).

Furthermore the table shows an actual lane rate example for the 2-, 1- and 1/2-wire interface, 18-bit output resolution and real decimation by 4.

DECIMATION SETTING	ADC SAMPLING RATE	OUTPUT RESOLUTION # of WIRES F		FCLK	DCLKIN, DCLK	DA/B0,1	
М	F <sub>S</sub>	R	L	$F_{S} / M / 2 (L = 2)$ $F_{S} / M (L = 1, 1/2)$	[DA/B0,1] / 2	F <sub>S</sub> x R / L / M	
	65 MSPS	18	2	8.125 MHz	73.125 MHz	146.25 MHz	
4			1	16.25 MHz	146.25 MHz	292.5 MHz	
			1/2	10.23 10112	292.5 MHz	585 MHz	

表 8-5. Serial LVDS Lane Rate Exam	ples with Real Decimation an	d 18-bit Output Resolution



### 8.3.5 Digital Interface

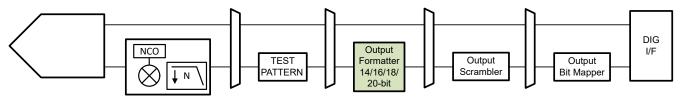
The serial LVDS interface supports the data output with 2-wire, 1-wire and 1/2-wire operation. The actual data output rate depends on the output resolution and number of lanes used.

The ADC368x requires an external serial LVDS clock input (DCLKIN), which is used to transmit the data out of the ADC along with the data clock (DCLK). The phase relationship between DCLKIN and the sampling clock is irrelevant but both clocks need to be frequency locked. The SLVDS interface is configured using SPI register writes.

### 8.3.5.1 Output Formatter

The digital output interface uses a flexible output bit mapper ( $\boxtimes$  8-40). The bit mapper takes the 18-bit output directly from the ADC or from the digital decimation filter block and reformats it to a resolution of 14,16,18 or 20-bit. The output serialization factor is adjusted accordingly for 2-, 1- and 1/2-wire interface modes. The maximum SLVDS interface output data rate can not be exceeded independent of output resolution or serialization factor.

For 14 and 16-bit output resolution, the LSBs are truncated during the reformatting. With 20-bit output, in bypass mode two 0s are added in place of the two LSBs while in decimation mode and the digital averaging mode the full 20-bit output is used.



# 图 8-40. Interface output bit mapper

**8-6** provides an overview for the resulting serialization factor depending on output resolution and output modes. Note that the DCLKIN frequency needs to be adjusted accordingly as well. Changing the output resolution to 16-bit, 2-wire mode for example results in DCLKIN = F<sub>S</sub> \* 4 instead of \* 4.5.

OUTPUT RESOLUTION	Interface	SERIALIZATION	FCLK	DCLKIN	DCLK	D0/D1
	2-Wire	7x	F <sub>S</sub> /2	F <sub>S</sub> * 3.5	F <sub>S</sub> * 3.5	F <sub>S</sub> * 7
14-bit	1-Wire	14x	F <sub>S</sub>	F <sub>S</sub> * 7	F <sub>S</sub> * 7	F <sub>S</sub> * 14
	1/2-Wire	28x	F <sub>S</sub>	F <sub>S</sub> * 14	F <sub>S</sub> * 14	F <sub>S</sub> * 28
	2-Wire	8x	F <sub>S</sub> /2	F <sub>S</sub> * 4	F <sub>S</sub> * 4	F <sub>S</sub> * 8
16-bit	1-Wire	16x	F <sub>S</sub>	F <sub>S</sub> * 8	F <sub>S</sub> * 8	F <sub>S</sub> * 16
	1/2-Wire	32x	F <sub>S</sub>	F <sub>S</sub> * 16	F <sub>S</sub> * 16	F <sub>S</sub> * 32
	2-Wire	9x	F <sub>S</sub> /2	F <sub>S</sub> * 4.5	F <sub>S</sub> * 4.5	F <sub>S</sub> * 9
18-bit (default)	1-Wire	18x	F <sub>S</sub>	F <sub>S</sub> * 9	F <sub>S</sub> * 9	F <sub>S</sub> * 18
	1/2-Wire	36x	F <sub>S</sub>	F <sub>S</sub> * 18	F <sub>S</sub> * 18	F <sub>S</sub> * 36
	2-Wire	10x	F <sub>S</sub> /2	F <sub>S</sub> * 5	F <sub>S</sub> * 5	F <sub>S</sub> * 10
20-bit	1-Wire	20x	F <sub>S</sub>	F <sub>S</sub> * 10	F <sub>S</sub> * 10	F <sub>S</sub> * 20
	1/2-Wire	40x	F <sub>S</sub>	F <sub>S</sub> * 20	F <sub>S</sub> * 20	F <sub>S</sub> * 40

表 8-6. Serialization factor vs output resolution for different output	ut modes
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The programming sequence to change the output interface and/or resolution from default settings is shown in  $\ddagger$  8.3.5.4.



### 8.3.5.2 Output Scrambler

The device includes an optional output scrambler feature. Scrambling is performed on each serial output lane independently. When enabled, the serial output bit stream is scrambled where each output bit is XOR-ed with 2 previous bits (k-14 and k-15) as shown in  $\mathbb{E}$  8-42. For descrambling, note that the output bit mapper is located after the scrambler.

On the external receiver, the incoming serial data stream can be descrambled by XOR-ing each incoming bit with 2 previous bits (k-14 and k-15).

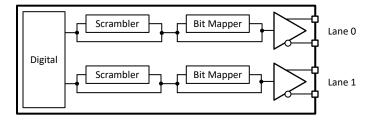
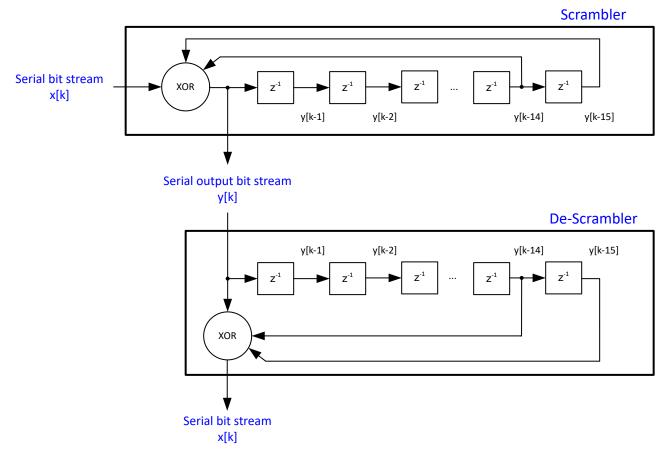


图 8-41. Output scrambling per lane



### 图 8-42. Output scrambler and descrambler operation

Scrambling is enabled by disabling digital bypass (register 0x24, D2) and enabling scrambling (register 0x22, D6).



# 8.3.5.3 Output Bit Mapper

The output bit mapper allows change to the output bit order for any selected interface mode.

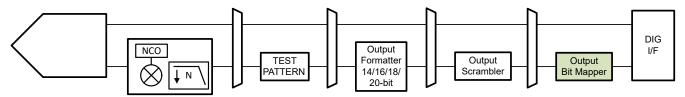


图 8-43. Output Bit Mapper

There is a two step process to change the output bit mapping and assemble the output data bus:

- Both channel A and B can have up to 20-bit output. Each output bit of either channel has a unique identifier bit as shown in 表 8-7. The MSB starts with bit D19, depending on output resolution chosen, the LSB is D6 (14-bit) to D0 (20-bit). The *previous sample* is only needed in 2-w mode.
- 2. The bit mapper is then used to assemble the output sample. The following sections detail how to remap the serial output format.

Bit	Chan	nel A	Channel B				
	Previous sample (2w only)	Current sample	Previous sample (2w only)	Current sample			
D19 (MSB)	0x2D	0x6D	0x29	0x69			
D18	0x2C	0x6C	0x28	0x68			
D17	0x27	0x67	0x23	0x63			
D16	0x26	0x66	0x22	0x62			
D15	0x25	0x65	0x21	0x61			
D14	0x24	0x64	0x20	0x60			
D13	0x1F	0x5F	0x1B	0x5B			
D12	0x1E	0x5E	0x1A	0x5A			
D11	0x1D	0x5D	0x19	0x59			
D10	0x1C	0x5C	0x18	0x58			
D9	0x17	0x57	0x13	0x53			
D8	0x16	0x56	0x12	0x52			
D7	0x15	0x55	0x11	0x51			
D6	0x14	0x54	0x10	0x50			
D5	0x0F	0x4F	0x0B	0x4B			
D4	0x0E	0x4E	0x0A	0x4A			
D3	0x0D	0x4D	0x09	0x49			
D2	0x0C	0x4C	0x08	0x48			
D1	0x07	0x47	0x03	0x43			
D0 (LSB)	0x06	0x46	0x02	0x42			

表 8-7. Unique identifier of each data bit

In the serial output mode, a data bit (with unique identifier) needs to be assigned to each location within the serial output stream. There are a total of 40 addresses available per channel. Channel A spans from address 0x39 to 0x60 and channel B from address 0x61 to 0x88. When using complex decimation, the output bit mapper is applied to both the "I" and the "Q" sample.



**2-wire mode**: in this mode, both the current and the previous sample have to be used in the address space as shown in  $\mathbb{R}$  8-44. The address order is different for 14/18-bit and 16/20-bit. Note: there are unused addresses between samples for resolution less than 20-bit (grey back ground), which can be skipped if not used.

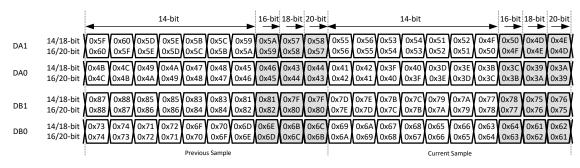


图 8-44. 2-wire output bit mapper

	Previous Sample						Current Sample									
DA1	D19 <sub>A</sub>	D18 <sub>A</sub>	D17 <sub>A</sub>	D16 <sub>A</sub>	D15 <sub>A</sub>	D14 <sub>A</sub>	D13 <sub>A</sub>	D12 <sub>A</sub>	D19 <sub>A</sub>	D18 <sub>A</sub>	D17 <sub>A</sub>	D16 <sub>A</sub>	D15 <sub>A</sub>	D14 <sub>A</sub>	D13 <sub>A</sub>	D12 <sub>A</sub>
	(0x60	(0x5F	(0x5E	(0x5D	(0x5C	(0x5B	(0x5A	(0x59	(0x56	(0x55	(0x54	(0x53	(0x52	(0x51	(0x50	(0x4F
	0x2D)	0x2C)	0x27)	0x26)	0x25)	0x24)	0x1F)	0x1E)	0x6D)	0x6C)	0x67)	0x66)	0x65)	0x64)	0x5F)	0x5E)
DA0	D11 <sub>A</sub>	D10 <sub>A</sub>	D9 <sub>A</sub>	D8 <sub>A</sub>	D7 <sub>A</sub>	D6 <sub>A</sub>	D5 <sub>A</sub>	D4 <sub>A</sub>	D11 <sub>A</sub>	D10 <sub>A</sub>	D9 <sub>A</sub>	D8 <sub>A</sub>	D7 <sub>A</sub>	D6 <sub>A</sub>	D5 <sub>A</sub>	D4 <sub>A</sub>
	(0x4C	(0x4B	(0x4A	(0x49	(0x48	(0x47	(0x46	(0x45	(0x42	(0x41	(0x40	(0x39	(0x38	(0x37	(0x36	(0x35
	0x1D)	0x1C)	0x17)	0x16)	0x15)	0x14)	0x0F)	0x0E)	0x5D)	0x5C)	0x57)	0x56)	0x55)	0x54)	0x4F)	0x4E)
DB1	D19 <sub>B</sub>	D18 <sub>B</sub>	D17 <sub>B</sub>	D16 <sub>B</sub>	D15 <sub>B</sub>	D14 <sub>B</sub>	D13 <sub>B</sub>	D12 <sub>B</sub>	D19 <sub>B</sub>	D18 <sub>B</sub>	D17 <sub>B</sub>	D16 <sub>B</sub>	D15 <sub>B</sub>	D14 <sub>B</sub>	D13 <sub>B</sub>	D12 <sub>B</sub>
	(0x88	(0x87	(0x86	(0x85	(0x84	(0x83	(0x82	(0x81	(0x7E	(0x7D	(0x7C	(0x7B	(0x7A	(0x79	(0x78	(0x77
	0x29)	0x28)	0x23)	0x22)	0x21)	0x20)	0x1B)	0x1A)	0x69)	0x68)	0x63)	0x62)	0x61)	0x60)	0x5B)	0x5A)
DB0	D11 <sub>B</sub>	D10 <sub>B</sub>	D9 <sub>B</sub>	D8 <sub>B</sub>	D7 <sub>B</sub>	D6 <sub>B</sub>	D5 <sub>B</sub>	D4 <sub>8</sub>	D11 <sub>8</sub>	D10 <sub>B</sub>	D9 <sub>B</sub>	D8 <sub>B</sub>	D7 <sub>B</sub>	D6 <sub>8</sub>	D5 <sub>B</sub>	D4 <sub>B</sub>
	(0x74	(0x73	(0x72	(0x71	(0x70	(0x6F	(0x6E	(0x6D	(0x6A	(0x69	(0x68	(0x67	(0x66	(0x65	(0x64	(0x63
	0x19)	0x18)	0x13)	0x12)	0x11)	0x10)	0x0B)	0x0A)	0x59)	0x58)	0x53)	0x52)	0x51)	0x50)	0x4B)	0x4A)

图 8-45. Example: 2-wire output bit mapping

**1-wire mode**: Only the 'current' sample needs to programmed in the address space. A duplicated can be created on DA1/DB1 as well (using addresses shown below) to have a redundant output. Lane DA1/DB1 needs to be powered up.

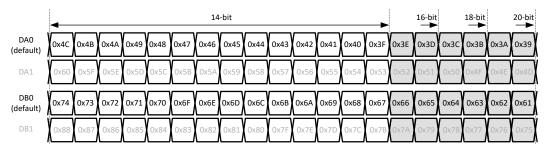
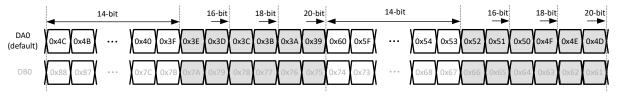
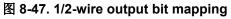


图 8-46. 1-wire output bit mapping

 $\frac{1}{2}$ -wire mode: The output is only lane DA0 and the sample order is programmed into the 40 addresses of chA (from 0x39 to 0x60). This covers 2 samples (one for chA, one for chB) as shown below. A duplicate can be created on DB0 as well (using addresses shown in 🕅 8-47) to have a redundant output. Lane DB0 must be powered up.







### 8.3.5.4 Output Interface/Mode Configuration

The following sequence summarizes all the relevant registers for changing the output interface and/or enabling the decimation filter. Steps 1 and 2 must come first since the E-Fuse load reset the SPI writes, the remaining steps can come in any order.

STEP	FEATURE	ADDRESS	DESCRIPTION							
			Select the output in	terface bit mapping d	lepending on resoluti	on and output interfa	ice.			
			Output R	esolution	2-wire	1-wire	1/2-wire			
			14	-bit	0x2B					
1		0x07	16	-bit	0x4B					
			18	-bit	0x2B	0x6C	0x8D			
			20	-bit	0x4B					
2	-	0x13		erface bit mapping us that bit mapping is l			n register 0x13 to			
			Configure the FCLK	frequency based on	bypass/decimation	and number of lanes	used.			
			Bypass/Dec	SLVDS	FCLK SRC (D7)	FCLK DIV (D4)	TOG FCLK (D0)			
				2-wire	0	1	0			
3		0x19	Bypass/ Real Decimation	1-wire	0	0	0			
			Decimation	1/2-wire	0	0	0			
				2-wire	1	0	0			
	Output		Complex Decimation	1-wire	1	0	0			
	Interface		Decimation	1/2-wire	0	0	1			
4		0x1B	Select the output in	terface resolution usi	ng the bit mapper (D	5-D3).				
			Select the FCLK pattern for decimation for proper duty cycle output of the frame clock.							
		0x20 0x21		Output Resolution	2-wire	1-wire	1/2-wire			
				14-bit		0xFE000				
			)x21	16-bit	use default	0xFF000	use default			
5				18-bit		0xFF800	use delault			
5		0x22		20-bit		0xFFC00 0xFFFFF				
				14-bit						
			Complex	16-bit			0xFFFFF			
			Decimation	18-bit			UXI I I I I			
			20-bit							
6		0x390x60 0x610x88	Change output bit n selection.	napping for chA and	chB if desired. This v	vorks also with the de	efault interface			
7		0x24 0x22	Enable scrambling							
8		0x24	Enable the decimat	ion filter						
9		0x25	Configure the decin	nation filter						
10	-	0x2A/B/C/D 0x31/2/3/4	Program the NCO frequency for complex decimation (can be skipped for real decimation)							
	Decimation		Configure the comp	lex output data strea	m (set both bits to 0	for real decimation)				
	Filter	o o=	SLVDS			OP-Order (D4)	Q-Delay (D3)			
11		0x27 0x2E	2-wire			1	0			
			1-wire			0	1			
			1/2-wire			1	1			
12		0x26	Set the mixer gain a	and toggle the mixer	reset bit to update th	e NCO frequency.				

## 表 8-8. Configuration steps for changing interface or decimation



### 8.3.5.4.1 Configuration Example

The following is a step by step programming example to configure the ADC368x to complex decimation by 8 with 1-wire SLVDS and 16-bit output.

- 1. 0x07 (address) 0x6C (load bit mapper configuration for 16-bit output with 1-wire SLVDS)
- 2. 0x13 0x01, wait 1 ms, 0x13 0x00 (load e-fuse)
- 3. 0x19 0x80 (configure FCLK)
- 4. 0x1B 0x88 (select 16-bit output resolution)
- 5. 0x20 0xFF, 0x21 0xFF, 0x22 0x0F (configure FCLK pattern)
- 6. 0x24 0x06 (enable decimation filter)
- 7. 0x25 0x30 (configure complex decimation by 8)
- 8. 0x2A/B/C/D and 0x31/32/33/34 (program NCO frequency)
- 9. 0x27/0x2E 0x08 (configure Q-delay register bit)
- 10. 0x26 0xAA, 0x26 0x88 (set digital mixer gain to 6-dB and toggle the mixer update)

### 8.3.5.5 Output Data Format

The output data can be configured to two's complement (default) or offset binary formatting using SPI register writes (register 0x8F and 0x92).  $\gtrsim 8-9$  provides an overview for minimum and maximum output codes for the two formatting options. The actual output resolution is set by the output bit mapper.

### 表 8-9. Overview of minimum and maximum output codes vs output resolution for different formatting

	٦	wo's Comple	mplement (default) Offset Binary					
RESOLUTION (BIT)	14	16	18	20	14	16	18	20
V <sub>IN,MAX</sub>	0x1FFF	0x7FFF	0x1FFFF	0x7FFFF	0x3FFF	0xFFFF	0x3FFFF	0xFFFFF
0	0x0	000	0x00	0000	0x2000	0x8000	0x20000	0x80000
V <sub>IN,MIN</sub>	0x2000	0x8000	0x20000	0x80000	0x0	000	0x00	0000

### 8.3.6 Test Pattern

In order to enable in-circuit testing of the digital interface, the following test patterns are supported and enabled via SPI register writes (0x14/0x15/0x16). The test pattern generator is located after the decimation filter as shown in 8 8-48. In decimation mode (real and complex), the test patterns replace the output data of the DDC - however channel A controls the test patterns for both channels.

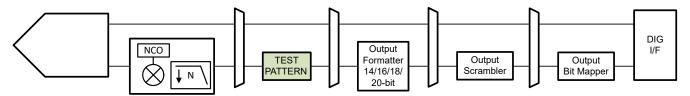


图 8-48. Test Pattern Generator

- RAMP Pattern: The step size needs to be configured in the CUSTOM PAT register according to the native resolution of the ADC. When selecting a higher output resolution then the additional LSBs will still be 0 in RAMP pattern mode.
  - 00001: 18-bit output resolution
  - 00100: 16-bit output resolution
  - 10000: 14-bit output resolution
- · Custom Pattern: Configured in the CUSTOM PAT register



### 8.4 Device Functional Modes

# 8.4.1 Normal Operation

In normal operating mode, the entire ADC full-scale range gets converted to a digital output with 18-bit resolution.

### 8.4.2 Power Down Options

A global power down mode can be enabled via SPI as well as using the power down pin (PDN/SYNC). There is an internal pull-down 21 k  $\Omega$  resistor on the PDN/SYNC input pin and the pin is active high - so the pin needs to be pulled high externally to enter global power down mode.

The SPI register map provides the capability to enable/disable individual blocks directly or via PDN pin mask in order to trade off power consumption vs wake up time as shown in  $\frac{1}{5}$  8-10.

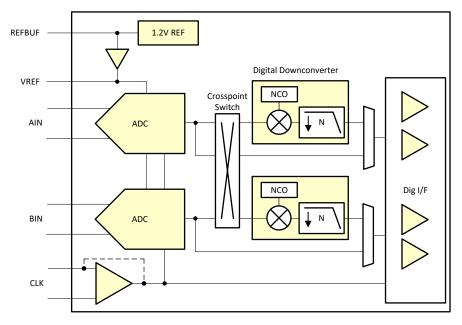


图 8-49. Power Down Configurations

表 8-10.	Overview	of Power	Down	Options
---------	----------	----------	------	---------

Function/ Register	PDN via SPI	Mask for Global PDN	Feature - Default	Power Impact	Wake-up time	Comment	
ADC	Yes	-	Enabled			Both ADC channels are included in Global PDN automatically	
Reference gain amplifier	Yes		Enabled	~ 0.4 mA	~3 us	Should only be powered down in power down state.	
Internal 1.2V reference	Yes	Ves	Yes	External ref	~ 1-3.5 mA	~3 ms	Internal/external reference selection is available through SPI and REFBUF pin.
Clock buffer	Yes		Differential clock	~ 1 mA	n/a	Single ended clock input saves ~ 1mA compared to differential. Some programmability is available through the REFBUF pin.	
Output interface drivers	Yes	-	Enabled	varies	n/a	Depending on output interface mode, unused output drivers can be powered down for maximum power savings	
Decimation filter	Yes	-	Disabled	see electrical table	n/a		



### 8.4.3 Digital Channel Averaging

The ADC368x includes a digital channel averaging feature which enables improvement of the ADC dynamic range (see 😤 8-50). The same input signal is given to both ADC inputs externally and the output of the two ADCs is averaged internally. By averaging, uncorrelated noise (e.g. ADC thermal noise) improves 3-dB while correlated noise (e.g. jitter in the clock path, reference noise) is unaffected. Therefore the averaging gives close to 3-dB improvement at low input frequencies but less at high input frequencies where clock jitter dominates the SNR.

The output from the digital averaging block is given out on the digital outputs of channel A or alternatively can be routed to the digital decimation filters using the digital mux.

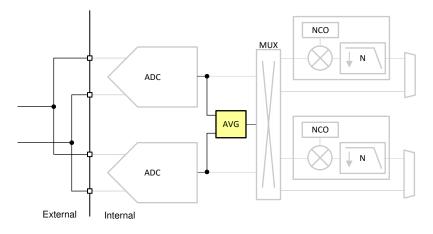


图 8-50. Digital Channel Averaging Diagram



# 8.5 Programming

The device is primarily configured and controlled using the serial programming interface (SPI); however, the device can operate in a default configuration without requiring the SPI interface. Also, the power down function and internal or external reference configuration is possible via pin control (PDN/SYNC and REFBUF pin).

```
备注
The power down command (via PIN or SPI) only goes in effect with the ADC sampling clock present.
```

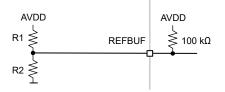
After initial power up, the default operating configuration for each device is shown in  $\frac{1}{8}$  8-11.

FEATURE	ADC3681 ADC3682 ADC3683						
Signal Input		Differential					
Auto-zero	Enabled	Enabled Enabled Disabled					
Clock Input	Differential						
Reference		External					
Decimation		DDC bypass					
Interface	1-wire 1-wire 2-wire						
Output Format	2s complement						

表 8-11. Default device configuration after power up

# 8.5.1 Configuration using PINs only

The ADC voltage reference can be selected using the REFBUF pin. Even though there is an internal 100 k $\Omega$  pull-up resistor to AVDD, the REFBUF pin should be set to a voltage externally and not left floating. When using a voltage divider to set the REFBUF voltage (R1 and R2 in  $\mathbb{R}$  8-51), resistor values < 5 k $\Omega$  should be used.



# 图 8-51. Configuration of external voltage on REFBUF pin

· · · · · · · · · · · · · · · · · · ·	U	
REFBUF VOLTAGE	VOLTAGE REFERENCE OPTION	CLOCKING OPTION
> 1.7 V (Default)	External reference	Differential clock input
1.2 V (1.15-1.25V)	External 1.2V input on REFBUF pin using internal gain buffer	Differential clock input
0.5 - 0.7V	Internal reference	Differential clock input
< 0.1V	Internal reference	Single ended clock input

表 8-12. REFBUF voltage l	evels control voltage reference selection
	evers control voltage reference selection

# 8.5.2 Configuration using the SPI interface

The device has a set of internal registers that can be accessed by the serial interface formed by the SEN (serial interface enable), SCLK (serial interface clock) and SDIO (serial interface data input/output) pins. Serially shifting bits into the device is enabled when SEN is low. Serial data input are latched at every SCLK rising edge when SEN is active (low). The serial data are loaded into the register at every 24th SCLK rising edge when SEN is low. When the word length exceeds a multiple of 24 bits, the excess bits are ignored. Data can be loaded in multiples of 24-bit words within a single active SEN pulse. The interface can function with SCLK frequencies from 12 MHz down to very low speeds (of a few hertz) and also with a non-50% SCLK duty cycle.

# 8.5.2.1 Register Write

The internal registers can be programmed following these steps:



- 1. Drive the SEN pin low
- 2. Set the R/W bit to 0 (bit A15 of the 16-bit address) and bits A[14:12] in address field to 0.
- 3. Initiate a serial interface cycle by specifying the address of the register (A[11:0]) whose content is written and
- 4. Write the 8-bit data that are latched in on the SCLK rising edges

图 8-52 shows the timing requirements for the serial register write operation.

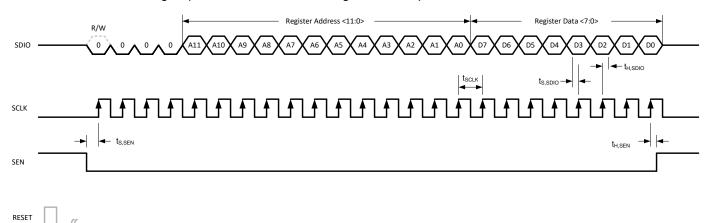
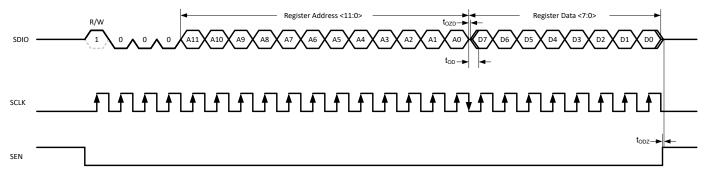


图 8-52. Serial Register Write Timing Diagram

### 8.5.2.2 Register Read

The device includes a mode where the contents of the internal registers can be read back using the SDIO pin. This readback mode can be useful as a diagnostic check to verify the serial interface communication between the external controller and the ADC. The procedure to read the contents of the serial registers is as follows:

- 1. Drive the SEN pin low
- 2. Set the R/W bit (A15) to 1. This setting disables any further writes to the registers. Set A[14:12] in address field to 0.
- 3. Initiate a serial interface cycle specifying the address of the register (A[11:0]) whose content must be read
- 4. The device launches the contents (D[7:0]) of the selected register on the SDIO pin on SCLK falling edge
- 5. The external controller can capture the contents on the SCLK rising edge







# 8.6 Register Map

ADJRESS INApplicationD7D6D5D4D3D2D1D00x000000000RESET0x07 $\bigcirc$ PIF MAPPET0 $\bigcirc$ PPN $\bigcirc$ PPNPPNPPNAPDN BAPDN BAPDN BA0x0800PDN CLKBUFREFAMPPDN DA1PDN DA1PDN DB1PDN DB1PDN DB10x090000CLKBUFREFAMPREFAMPMASKMASK BGQLDBA0x000000000CLKBUFSECLK EN0x01000000DAZ EN0x11000000DAZ EN0x11000000AZ EN0x1300000DAZ EN0x14000000CLSTA0x15FEST PAT [15:8]CUSTOM PAT [15:8]CUSTOM PAT [17:9]SCISTOM PAT [17:9]0x16MAPPER N20000000x14MAPPER N20000000x14MAPPER N20CUSTS ½CUSTOM PAT [17:9]CUSTOM PAT [17:9]0x21SCR SR00000000x14MAPPER NMAPPER NREAL NNCS RESNCA RESSCA MA0x22<	REGISTER			A 0 10.10	REGISTER MAP					
0x00         0         0         0         0         0         0         0         RESET           0x07         OP IF MAPPER         0         OP IF EN         OP IF SEL         PON           0x08         0         0         PDN CLKBUF         PPN REFAMP         0         PDN A         PDN B         GLOBAL           0x09         0         0         PDN CLKBUF         PPN REFAMP         PDN DA1         PDN DA         PDN DB1         PDN DB0           0x00         0         0         0         0         MASK CLKBUF         MASK REFAMP         MASK BG REFAMP         0         AZ EN           0x01         0         0         0         0         0         0         AZ EN           0x11         0         0         0         0         0         0         AZ EN           0x13         0         0         0         0         0         0         AZ EN           0x14          TEST PAT B         CUSTOM PATI [17:16]         CUSTOM PATI [17:16]         CUSTOM PATI [17:16]           0x14         0         LVDS X/L         0         0         0         0         0         0         0         0<				_						
0x07OP IF MAPPER0OP IF ENPDN APDN BCLOBAL CLOBAL0x0800PDN CLKBUF FCLKOUTPPN DCLKOUTPDN DA1PDN DAPDN DBPDN DBPDN DB0x00000PDN CLKBUFPDN DA1PDN DA0PDN DBPDN DBPDN DB0x00000REF CRLREFAMPMASK REFAMPMASK BG DISDO0E-FUSE LD0x1100000DL PON D00E-FUSE LD0x130000DL PON D0DE-FUSE LD0x14CTEST PAT BCUSTOW PAT [7:0]00CLUSTOW FAT [7:0]0x16FCLK SRC00FCLK DV000CCLSTOW0x14GO0CLUSTOW SVINC0000CCLSTOWTOG FCLK0x14GO00FCLK DV00000000x14GOO0CLUSTOWCLUSTOWUDS DVUDS DVUDS DVUDS DV000x14GOGOCHAYG ENGOOCLUSTOWTOG FCLK PAT [*0]UDS DV00000000000000000000000000000000000 <td< th=""><th></th><th></th><th>-</th><th>-</th><th></th><th></th><th></th><th></th><th></th></td<>			-	-						
0x0800PDN CLKBUFPEN REFAMP0PDN APDN BPDN GLOBAL0x0900PDNPDNDD LKOUTPDN DAGKPDN DAGKPDN DBPDN DB0x0000000MASK CLKBUFREF CRLREF CRMPARMASK BG00x010000000AZ EN0x110000000AZ EN0x130000000EF CRL0x13000000AZ EN0x14000000EF CRL0x15		-		-				-	0 RESET	
0x009000PDN CLROUTREFAMP PDN DCLKOUT0PDN A0PDN B1PDN B00x00000000PDN DA1PDN DA0PDN DA0PDN DA1PDN DA0PDN DA1PDN DA1	0x07		OP IF MAPPER	8	-	OP IF EN		OP IF SEL		
0.0000FCLKOUTDCLKOUTPED. No.PED. No. </td <td>0x08</td> <td>0</td> <td>0</td> <td>PDN CLKBUF</td> <td></td> <td>0</td> <td>PDN A</td> <td>PDN B</td> <td></td>	0x08	0	0	PDN CLKBUF		0	PDN A	PDN B		
0x00000CLKBUFREFAMPDIS00x01SYNC PIN ENSPI SYNC PIN SPI SYNC PINSPI SYNC PIN SPI SYNC PIN0REF CTRLREF ATRLSE CLK EN0x11000000AZ EN0x13000000EF USE LD0x13000000EF USE LD0x14000000EF USE LD0x15TEST PAT B0TEST PAT BCUSTOW PAT [T:1]0000x16MPPER PIN20 B ON0LVD S / NO00000x17MAPPER PIN20 B ON0LVD S / NO000000x18MAPPER PIN20 B ON0LVD S / NOLVD S / NO000000x14MAPPER PIN20 B ON00LVD S / NOLVD S / NO00 <t< td=""><td>0x09</td><td>0</td><td>0</td><td></td><td></td><td></td><td>PDN DA0</td><td>PDN DB1</td><td>PDN DB0</td></t<>	0x09	0	0				PDN DA0	PDN DB1	PDN DB0	
LNDE         EN         SPI SYNC         SPI SYNC EN         U         REF CRC         REF CRC         REF SEL         SE CLR EN           0x11         0         0         0         0         0         DLI PDN         0         AZ EN           0x13         0         0         0         0         0         0         AZ EN           0x14           CUSTOM PAT [7:5]          EFUS BAT         EFUS BAT           0x16         TEST PAT B          TEST PAT B         CUSTOM PAT [7:6]         TOG FCLK           0x19         FCLK SRC         0         0         FCLK DIV         0         0         0         0           0x14         0         LVDS ½         0         0         IVD          CUSTOM PAT [17:6]           0x14         0         SE EN         BIT MAPPER NET         0         0         0         0           0x14         MAPPER EN         20B EN         BIT MAPPER NET         TECLK PAT [7:0]         UVDS ULK DEL         DVC ULK DEL         0x21         MIX FARS         FCLK PAT [7:0]         MIX PASE         FS/4 MIX PA         MIX FARS         FS/4 MIX PA         MIX ES B         FS/4 MIX PA         A         O	0x0D	0	0	0	0				0	
0x13000000E-FUSE LD0x14	0x0E		SPI SYNC	SPI SYNC EN	0	REF CTRL	REF	SEL	SE CLK EN	
0x14USENCECUSTOM PAT [7:0]0x15TEST PAT BTEST PAT ACUSTOM PAT [15:8]0x19FCLK SRC00FCLK DIV00TOG FCLK0x140LVDS ½ SWING00000000x18MAPPER EN20B ENBIT MAPPER RE0000000x18MAPPER EN20B ENBIT MAPPER RE0000000x140SCR EN00LVDS D-T A DELLVDS D-K K DEL00x20SCR EN00FCLK PAT [19:16]00000x240SCR EN00FCLK PAT [19:16]00000x25DDC MUX ENMIX RES AFS/4 MIX AMIX CAIN BMIX RES BFS/4 MIX B0x26MIX GAIN AMIX RES AFS/4 MIX AMIX RES BFS/4 MIX B000x27000OP ORDER AQ-DEL AFS/4 MIX PH B0000x2800OP ORDER BQ-DEL BFS/4 MIX PH B0000x2600OP ORDER BQ-DEL BFS/4 MIX PH B0000x2600OP ORDER BQ-DEL BFS/4 MIX PH B0000x27000OP ORDER BQ-DEL BFS/4 MIX PH B0000x2800OP O	0x11	0	0	0	0	0	DLL PDN	0	AZ EN	
0x15CUSTOM PAT [15:8]0x16TEST PAT BCUSTOM PAT [17:16]0x19FCLK SRC00000TOG FCLK0x1A0LVDS ½ SWING SWING0000000x1BMAPPER EN20B ENBIT MAPPER RES000000x1E0000LVDS JATA DELLVDS DALK DELDAD0x20	0x13	0	0	0	0	0	0	0	E-FUSE LD	
0x16TEST PAT BTEST PAT BCUSTOM PAT [17:16]0x19FCLK SRC00FCLK DIV00TOG FCLK0x1A0LVDS ½ SWING00000000x1BMAPPER R20B ENBIT MAPPER RES000000x1E000LVDS DAT DELLVDS DCK DEL000x120SCR EN00LVDS DAT DELLVDS DCK DEL00x220SCR EN00SCR ENDDC MUXDIG BYPDDC EN00x2400CH AVG ENDDC MUXDIG BYPDDC EN0MIX PHASE0x25DDC MUX ENDECIMATIONREAL OU00MIX PHASE0x26MIX GAIN AMIX RES AFS/4 MIX AMIX RES BFS/4 MIX B0x27000OP ORDER AQ-DEL AFS/4 MIX PH A000x28CVVNCO A [2:8]SVV00x27000OP ORDER BQ-DEL BFS/4 MIX PH B0000x28CVVNCO A [2:8]NCO A [2:8]S000x2100OP ORDER BQ-DEL BFS/4 MIX PH B0000x2600OP ORDER BQ-DEL BFS/4 MIX PH B0000x31CVNCO B [2:8]S	0x14				CUSTOM	PAT [7:0]		•		
$ \begin{array}{c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	0x15				CUSTOM	PAT [15:8]				
0x1A0LVDS ½ SWING0000000x1BMAPPER EN20B ENBHAPPER EN0000000x1E000LVDS JA DELLVDS JA DELLVDS JA DELLVDS JA DEL0x200SCR EN0EVENT [7:0]JCC NUDC SCR0x220SCR EN0FCLK PT [19:16]000x2400CH AVG ENDDC LVDIG BYPDDC EN00x25DC MUX ENDECIMATIONREAL OUT00MIX PHASE0x26MIX GAIN AMIX RES AFS/4 MIX AMIX EAN BMIX RES BFS/4 MIX B0x27000OP ORDER AQ-DEL AFS/4 MIX PH A000x28000OP ORDER BQ-DEL BFS/4 MIX PH B000x2000OP ORDER BQ-DEL BFS/4 MIX PH B000x2100OP ORDER BQ-DEL BFS/4 MIX PH B000x3200OP ORDER BQ-DEL BFS/4 MIX PH B000x330VVNCO B [3:24]VVV0x3400O0OPCRMAT00x3400000FORMAT00x3500000FORMAT0	0x16		TEST PAT B			TEST PAT A		CUSTOM	PAT [17:16]	
OKIA         O         SWING         O         CVDS DCL DEL         DC         DC         DC         O	0x19	FCLK SRC	0	0	FCLK DIV	0	0	0	TOG FCLK	
0x1E         0         0         LVDS DATA DEL         DUC         D	0x1A	0		0	0	0	0	0	0	
0x20         Image: FCLK PAT [7:0]           0x21         FCLK PAT [13:8]           0x22         0         SCR EN         0         FCLK PAT [19:16]           0x24         0         0         CH AVG EN         DIC MUX         DIG BYP         DDC EN         0           0x25         DDC MUX EN         CH AVG EN         REAL OUT         0         MIX RES B         FS/4 MIX A           0x26         MIX GAN         MIX RES A         FS/4 MIX A         MIX RES B         FS/4 MIX B           0x27         0         0         Q         OP ORDER A         Q-DEL A         FS/4 MIX PH         A         O           0x26         MIX GAN         Q         Q-DEL A         FS/4 MIX PH         A         O         O         O           0x27         O         0         Q         OP ORDER A         Q-DEL A         FS/4 MIX PH         A         O         O           0x28         C         T         T         NCO < [15:3]	0x1B	MAPPER EN	20B EN	В	IT MAPPER RE	S	0	0	0	
0x21         Image: Secret and the second secon	0x1E	0	0	0	0	LVDS D	ATA DEL	LVDS D	CLK DEL	
0x22         0         SCR EN         0         0         FCLK PAT [19:16]           0x24         0         0         CH AVG EN         DDC MUX         DIG BYP         DDC EN         0           0x25         DDC MUX EN          DECIMATION         REAL OUT         0         0         MIX RES B           0x26         MIX GAIN A         MIX RES A         FS/4 MIX A         MIX RES B         FS/4 MIX B           0x27         0         0         0         OP ORDER A         Q-DEL A         FS/4 MIX PH A         0         0           0x27         0         0         0         OP ORDER A         Q-DEL A         FS/4 MIX PH A         0         0           0x28             NCO [31:24]         0         0           0x20          0         0         OP ORDER B         Q-DEL B         FS/4 MIX PH B         0         0           0x31            NCO B [7:0]              0x33            NCO B [31:24]              0x34	0x20		1		FCLK P	AT [7:0]				
0x2400CH AVG ENDDCUXDIG BYPDDC EN00x25DDC MUX EN $IIII = IIIIIIIIIIIIIIIIIIIIIIIIIIIIIII$	0x21				FCLK PA	AT [15:8]				
0x25DDC MUX ENDECIMATIONREAL OUT0MIX RES AFS/4 MIX A0x26MIX - IMIX RES AFS/4 MIX AMIX - IMIX RES BFS/4 MIX PI0x27000OP ORDER AQ-DEL A $FS/4$ MIX PI A000x2A<	0x22	0	SCR EN	0	0		FCLK PA	T [19:16]		
0x26         MIX GAIN A         MIX RES A         FS/4 MIX A         MIX $IX BB R$ FS/4 MIX B         MIX RES B         FS/4 MIX B         O           0x27         0         0         0         0P ORDER A         Q-DEL A $FS/4 MIX PH A$ 0         0           0x2A              NCO A [7:0]         0         0           0x2B             NCO A [7:0]           0         0           0x2B             NCO A [7:0]            0         0         0         0         0         0         0                 0	0x24	0	0	CH AVG EN	DDC	MUX	DIG BYP	DDC EN	0	
0x27         0         0         0         0P ORDER A         Q-DEL A $FS/4$ MIX PH A         0         0           0x2A           NCO A $()$ A         0         0           0x2A           NCO A $()$ $($	0x25	DDC MUX EN		DECIMATION		REAL OUT	0	0	MIX PHASE	
0x27         0         0         0         0         0         0         A         0         0           0x2A	0x26	MIX G	SAIN A	MIX RES A	FS/4 MIX A	MIX G	SAIN B	MIX RES B	FS/4 MIX B	
0x2B         NCO A [15:8]           0x2C         NCO A [23:16]           0x2D         NCO A [31:24]           0x2E         0<	0x27	0	0	0	OP ORDER A	Q-DEL A		0	0	
0x2C       Image: Second	0x2A		1		NCO /	A [7:0]		I		
0x2D         NCO A [31:24]           0x2E         0         0         0P ORDER B         Q-DEL B         FS/4 MIX PH B         0         0         0           0x31         C         NCO B [7:0]         NCO B [7:0]         V <td>0x2B</td> <td></td> <td></td> <td></td> <td>NCO A</td> <td>[15:8]</td> <td></td> <td></td> <td></td>	0x2B				NCO A	[15:8]				
0x2E         0         0         0P ORDER B         Q-DEL B         FS/4 MIX PH B         0         0           0x31	0x2C				NCO A	[23:16]				
0x2E         0         0         0P ORDER B         Q-DEL B         FS/4 MIX PH B         0         0           0x31	0x2D				NCO A	[31:24]				
NCO B [15:8]         0x32	0x2E	0	0	0				0	0	
NCO B [15:8]         0x32	0x31									
NCO B [23:16]         0x33       V       NCO B [31:24]         0x390x60       OUTPUT BIT MAPPER CHA       V         0x610x88       OUTPUT BIT MAPPER CHB       V         0x8F       0       0       0       0       FORMAT A       0	0x32									
0x34         NCO B [31:24]           0x390x60         OUTPUT BIT MAPPER CHA           0x610x88         OUTPUT BIT MAPPER CHB           0x8F         0         0         0         0         FORMATA         0	0x33									
0x390x60         OUTPUT BIT MAPPER CHA           0x610x88         OUTPUT BIT MAPPER CHB           0x8F         0         0         0         0         FORMAT A         0	0x34									
0x610x88         OUTPUT BIT MAPPER CHB           0x8F         0         0         0         0         FORMAT A         0										
0x8F         0         0         0         0         0         FORMAT A         0										
		0	0	0			0	FORMAT A	0	
	0x92	0	0	0	0	0	0	FORMAT B	0	

# 表 8-13. Register Map Summary



### 8.6.1 Detailed Register Description

	A 8-54. Register 0x00									
7	6	5	4	3	2	1	0			
0	0	0	0	0	0	0	RESET			
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0			

团 O EA Destates Ov00

### 表 8-14. Register 0x00 Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	R/W	0	Must write 0
0	RESET	R/W	0	This bit resets all internal registers to the default values and self clears to 0.

### 图 8-55. Register 0x07

				<u> </u>			
7	6	5	4	3	2	1	0
	OP IF MAPPER		0	OP IF EN		OP IF SEL	
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

Bit	Field	Туре	Reset	Description				
7-5	OP IF MAPPER	R/W	000	Output interface mapper. This register contains the proper output interface bit mapping for the different interfaces. The interface bit mapping is internally loaded from e-fuses and also requires a fuse load command to go into effect (0x13, D0). Register 0x07 along with the E-Fuse Load (0x13, D0) needs to be loaded first in the programming sequence since the E-Fuse load resets the SPI writes. After initial reset the default output interface variant is loaded automatically from fuse internally. However when reading back this register reads 000 until a value is written using SPI. 001: 2-wire, 18 and 14-bit 010: 2-wire, 16-bit 011: 1-wire 100: 0.5-wire others: not used				
4	0	R/W	0	Must write 0				
3	OP IF EN	R/W	0	Enables changing the default output interface mode (D2-D0).				
2-0	OP IF SEL	R/W	000	Selection of the output interface mode. OP IF EN (D3) needs to be enabled also. After initial reset the default output interface is loaded automatically from fuse internally. However when reading back this register reads 000 until a value is written using SPI. 011: 2-wire 100: 1-wire 101: 0.5-wire others: not used				

# 表 8-15. Register 0x07 Field Descriptions



	图 8-56. Register 0x08								
7	6	5	4	3	2	1	0		
0	0	PDN CLKBUF	PDN REFAMP	0	PDN A	PDN B	PDN GLOBAL		
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

# 表 8-16. Register 0x08 Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	R/W	0	Must write 0
5	PDN CLKBUF	R/W	0	Powers down sampling clock buffer 0: Clock buffer enabled 1: Clock buffer powered down
4	PDN REFAMP	R/W	0	Powers down internal reference gain amplifier 0: REFAMP enabled 1: REFAMP powered down
3	0	R/W	0	Must write 0
2	PDN B	R/W	0	Powers down ADC channel A 0: ADC channel A enabled 1: ADC channel A powered down
1	PDN A	R/W	0	Powers down ADC channel B 0: ADC channel B enabled 1: ADC channel B powered down
0	PDN GLOBAL	R/W	0	Global power down via SPI 0: Global power disabled 1: Global power down enabled. Power down mask (register 0x0D) determines which internal blocks are powered down.

# 图 8-57. Register 0x09

7	6	5	4	3	2	1	0
0	0	PDN FCLKOUT	PDN DCLKOUT	PDN DA1	PDN DA0	PDN DB1	PDN DB0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

Bit	Field	Туре	Reset	Description
7-6	0	R/W	0	Must write 0
5	PDN FCLKOUT	R/W	0	Powers down frame clock (FCLK) LVDS output buffer 0: FCLK output buffer enabled 1: FCLK output buffer powered down
4	PDN DCLKOUT	R/W	0	Powers down DCLK LVDS output buffer 0: DCLK output buffer enabled 1: DCLK output buffer powered down
3	PDN DA1	R/W	0	Powers down LVDS output buffer for channel A, lane 1. NOT powered down automatically in 1-wire and 1/2-wire mode. 0: DA1 LVDS output buffer enabled 1: DA1 LVDS output buffer powered down
2	PDN DA0	R/W	0	Powers down LVDS output buffer for channel A, lane 0. 0: DA0 LVDS output buffer enabled 1: DA0 LVDS output buffer powered down
1	PDN DB1	R/W	0	Powers down LVDS output buffer for channel B, lane 1. NOT powered down automatically in 1-wire and 1/2-wire mode. 0: DB1 LVDS output buffer enabled 1: DB1 LVDS output buffer powered down
0	PDN DB0	R/W	0	Powers down LVDS output buffer for channel B, lane 0. NOT powered down automatically in 1/2-wire mode. 0: DB0 LVDS output buffer enabled 1: DB0 LVDS output buffer powered down

# 表 8-17. Register 0x09 Field Descriptions



# 图 8-58. Register 0x0D (PDN GLOBAL MASK)

				(			
7	6	5	4	3	2	1	0
0	0	0	0	MASK CLKBUF	MASK REFAMP	MASK BG DIS	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

# 表 8-18. Register 0x0D Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	0	R/W	0	Must write 0
3	MASK CLKBUF	R/W	0	<ul> <li>Global power down mask control for sampling clock input buffer.</li> <li>0: Clock buffer will get powered down when global power down is exercised.</li> <li>1: Clock buffer will NOT get powered down when global power down is exercised.</li> </ul>
2	MASK REFAMP	R/W	0	<ul> <li>Global power down mask control for reference amplifier.</li> <li>0: Reference amplifier will get powered down when global power down is exercised.</li> <li>1: Reference amplifier will NOT get powered down when global power down is exercised.</li> </ul>
1	MASK BG DIS	R/W	0	<ul> <li>Global power down mask control for internal 1.2V bandgap voltage reference. Setting this bit reduces power consumption in global power down mode but increases the wake up time. See the power down option overview.</li> <li>0: Internal 1.2V bandgap voltage reference will NOT get powered down when global power down is exercised.</li> <li>1: Internal 1.2V bandgap voltage reference will get powered down when global power down is exercised.</li> </ul>
0	0	R/W	0	Must write 0



### 图 8-59. Register 0x0E

7	6	5	4	3	2	1	0
SYNC PIN EN	SPI SYNC	SPI SYNC EN	0	REF CTL	REF	SEL	SE CLK EN
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

# 表 8-19. Register 0x0E Field Descriptions

Bit	Field	Туре	Reset	Description
7	SYNC PIN EN	R/W	0	<ul> <li>This bit controls the functionality of the SYNC/PDN pin.</li> <li>0: SYNC/PDN pin exercises global power down mode when pin is pulled high.</li> <li>1: SYNC/PDN pin issues the SYNC command when pin is pulled high.</li> </ul>
6	SPI SYNC	R/W	0	Toggling this bit issues the SYNC command using the SPI register write. SYNC using SPI must be enabled as well (D5). This bit doesn't self reset to 0. 0: Normal operation 1: SYNC command issued.
5	SPI SYNC EN	R/W	0	This bit enables synchronization using SPI instead of the SYNC/PDN pin. 0: Synchronization using SPI register bit disabled. 1: Synchronization using SPI register bit enabled.
4	0	R/W	0	Must write 0
3	REF CTL	R/W	0	This bit determines if the REFBUF pin controls the voltage reference selection or the SPI register (D2-D1). 0: The REFBUF pin selects the voltage reference option. 1: Voltage reference is selected using SPI (D2-D1) and single ended clock using D0.
2-1	REF SEL	R/W	00	Selects of the voltage reference option. REF CTRL (D3) must be set to 1. 00: Internal reference 01: External voltage reference (1.2V) using internal reference buffer (REFBUF) 10: External voltage reference 11: not used
0	SE CLK EN	R/W	0	Selects single ended clock input and powers down the differential sampling clock input buffer. REF CRTL (D3) must be set to 1. 0: Differential clock input 1: Single ended clock input



### 图 8-60. Register 0x11

7	6	5	4	3	2	1	0	
0	0	0	0	0	DLL PDN	0	AZ EN	
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	

# 表 8-20. Register 0x11 Field Descriptions

Bit	Field	Туре	Reset	Description
7-3	0	R/W	0	Must write 0
2	DLL PDN	R/W	0	This register applies ONLY to the ADC3683. It powers down the internal DLL, which is used to adjust the sampling time. This register must only be enabled when operating at sampling rates below 40 MSPS. When DLL PDN bit is enabled the sampling time is directly dependent on sampling clock duty cycle (with a 50/50 duty the sampling time is $T_S/2$ ). 0: Sampling time is $T_S/4$ 1: Sampling time is $T_S/2$ (only for sampling rates below 40 MSPS).
1	0	R/W	0	Must write 0
0	AZ EN	R/W	0	This bit enables the internal auto-zero circuitry. It is enabled by default for the ADC3681/82 and disabled for the ADC3683. ADC3681/82: 0: Auto-zero enabled 1: Auto-zero disabled ADC3683: 0: Auto-zero disabled 1: Auto-zero enabled

### 图 8-61. Register 0x13

7	6	5	4	3	2	1	0
0	0	0	0	0	0		E-FUSE LD
R/W-0							

#### 表 8-21. Register 0x13 Field Descriptions

Bit	Field	Туре	Reset	Description						
7-1	0	R/W	0	Must write 0						
0	E-FUSE LD	R/W	0	This register bit loads the internal bit mapping for different interfaces. After setting the interface in register 0x07, this E- FUSE LD bit needs to be set to 1 and reset to 0 for loading to go into effect. Register 0x07 along with the E-Fuse Load (0x13, D0) needs to be loaded first in the programming sequence since the E-Fuse load resets the SPI writes. 0: E-FUSE LOAD set 1: E-FUSE LOAD reset						



图 8-62. Register 0x14/15/16								
7	7 6 5 4 3 2 1 0						0	
	CUSTOM PAT [7:0]							
			CUSTOM	PAT [15:8]				
	TEST PAT B TEST PAT A CUSTOM PAT [17:16]							
R/W-0	R/W-0	R/W-0	R/W-0 R/W-0 R/W-0 R/W-0 R/W-0					

#### 表 8-22. Register 0x14/15/16 Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	CUSTOM PAT [17:0]	R/W	0000000	<ul> <li>This register is used for two purposes:</li> <li>It sets the constant custom pattern starting from MSB</li> <li>It sets the RAMP pattern increment step size.</li> <li>00001: Ramp pattern for 18-bit ADC</li> <li>00100: Ramp pattern for 16-bit ADC</li> <li>10000: Ramp pattern for 14-bit ADC</li> </ul>
7-5	TEST PAT B	R/W	000	Enables test pattern output mode for channel B (NOTE: The test pattern is set prior to the bit mapper and is based on native resolution of the ADC starting from the MSB). These work in either output format. 000: Normal output mode (test pattern output disabled)
				010: Ramp pattern: need to set proper increment using CUSTOM PAT register 011: Constant Pattern using CUSTOM PAT [17:0] in register 0x14/15/16. others: not used
4-2	TEST PAT A	R/W	000	Enables test pattern output mode for channel A (NOTE: The test pattern is set prior to the bit mapper and is based on native resolution of the ADC starting from the MSB). These work in either output format.
				000: Normal output mode (test pattern output disabled) 010: Ramp pattern: need to set proper increment using CUSTOM PAT register 011: Constant Pattern using CUSTOM PAT [17:0] in register 0x14/15/16. others: not used



### 图 8-63. Register 0x19

7	6	5	4	3	2	1	0
FCLK SRC	0	0	FCLK DIV	0	0	0	TOG FCLK
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

### 表 8-23. Register 0x19 Field Descriptions

Bit	Field	Туре	Reset	Description
7	FCLK SRC	R/W	0	User has to select if FCLK signal comes from ADC or from DDC block. Here real decimation is treated same as bypass mode 0: FCLK generated from ADC. FCLK SRC set to 0 for DDC bypass, real decimation mode and 1/2-w complex decimation mode. 1: FCLK generated from DDC block. In complex decimation mode only this bit needs to be set for 2-w and 1-w output interface mode but NOT for 1/2-w mode.
6-5	0	R/W	0	Must write 0
4	FCLK DIV	R/W	0	<ul> <li>This bit needs to be set to 1 for 2-w output mode in bypass/real decimation mode only .</li> <li>0: All output interface modes except 2-w decimation bypass and real decimation mode.</li> <li>1: 2-w output interface mode for decimation bypass and real decimation.</li> </ul>
3-1	0	R/W	0	Must write 0
0	TOG FCLK	R/W	0	<ul> <li>This bit adjusts the FCLK signal appropriately for 1/2-wire mode where FCLK is stretched to cover channel A and channel B.</li> <li>This bit ONLY needs to be set in 1/2-wire mode with complex decimation mode.</li> <li>0: all other modes.</li> <li>1: FCLK for 1/2-wire complex decimation mode.</li> </ul>

# 表 8-24. Configuration of FCLK SRC and FCLK DIV Register Bits vs Serial Interface

BYPASS/DECIMATION	SERIAL INTERFACE	FCLK SRC	FCLK DIV	TOG FCLK
	2-wire	0	1	0
Decimation Bypass/ Real Decimation	1-wire	0	0	0
	1/2-wire	0	0	0
	2-wire	1	0	0
Complex Decimation	1-wire	1	0	0
	1/2-wire	0	0	1



#### 图 8-64. Register 0x1A

7	6	5	4	3	2	1	0
0	LVDS ½ SWING	0	0	0	0	0	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

# 表 8-25. Register 0x1A Field Descriptions

Bit	Field	Туре	Reset	Description
7	0	R/W	0	Must write 0
6	LVDS 1/2 SWING	R/W		This bit reduces the LVDS output current from 3.5mA to 1.75mA which reduces power consumption.
5-0	0	R/W	0	Must write 0

# 图 8-65. Register 0x1B

				5			
7	6	5	4	3	2	1	0
MAPPER EN	20B EN	E	BIT MAPPER RES			0	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

### 表 8-26. Register 0x1B Field Descriptions

Bit	Field	Туре	Reset	Description
7	MAPPER EN	R/W	0	This bit enables changing the resolution of the output (including output serialization factor) in bypass mode only. This bit is not needed for 20-bit resolution output. 0: Output bit mapper disabled. 1: Output bit mapper enabled.
6	20B EN	R/W	0	This bit enables 20-bit output resolution which can be useful for very high decimation settings so that quantization noise doesn't impact the ADC performance. 0: 20-bit output resolution disabled. 1: 20-bit output resolution enabled.
5-3	BIT MAPPER RES	R/W	000	Sets the output resolution using the bit mapper. MAPPER EN bit (D6) needs to be enabled when operating in bypass mode 000: 18 bit 001: 16 bit 010: 14 bit all others, n/a
2-0	0	R/W	0	Must write 0

#### 表 8-27. Register Settings for Output Bit Mapper vs Operating Mode

	<u> </u>	<u> </u>	
BYPASS/DECIMATION	OUTPUT RESOLUTION	MAPPER EN (D7)	BIT MAPPER RES (D5-D3)
Decimation Bypass	Resolution Change	1	000: 18-bit
Real Decimation	Resolution Change (default 18-bit)	0	001: 16-bit
Complex Decimation	Resolution Change (detault to-bit)	0	010: 14-bit



### 图 8-66. Register 0x1E

			· · · · · ·	5			
7	6	5	4	3	2	1	0
0	0	0	0	LVDS DA	ATA DEL	LVDS DO	CLK DEL
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

### 表 8-28. Register 0x1E Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	0	R/W	0	Must write 0
3-2	LVDS DATA DEL	R/W	00	These bits adjust the output timing of the SLVDS output data. 00: no delay 01: Data advanced by 50 ps 10: Data delayed by 50 ps 11: Data delayed by 100 ps
1-0	LVDS DCLK DEL	R/W	00	These bits adjust the output timing of the SLVDS DCLK output. 00: no delay 01: DCLK advanced by 50 ps 10: DCLK delayed by 50 ps 11: DCLK delayed by 100 ps

图 8-67. Register 0x20/21/22										
7	6         5         4         3         2         1         0									
	FCLK PAT [7:0]									
			FCLK P/	AT [15:8]						
0	0 SCR EN 0 0 FCLK PAT [19:16]									
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0			

#### 表 8-29. Register 0x20/21/22 Field Descriptions

Bit	Field	Туре	Reset	Description					
7-0	FCLK PAT [19:0]	R/W	0xFFC00	These bits can adjust the duty cycle of the FCLK. In decimation bypass mode the FCLK pattern gets adjusted automatically for the different output resolutions. 表 8-30 shows the proper FCLK pattern values for 1-wire and 1/2-wire in real/complex decimation.					
6	SCR EN	R/W	0	This bit enables the output data scrambler. Digital bypass (0x24, D2) needs to be set as well. 0: Output scrambling disabled 1: Output scrambling enabled					

### 表 8-30. FCLK Pattern for different resolution based on interface

DECIMATION	OUTPUT RESOLUTION	2-WIRE	1-WIRE	1/2-WIRE	
	14-bit		0xFE000		
REAL DECIMATION	16-bit		0xFF000	- Use Default	
REAL DECIMATION	18-bit		0xFF800		
	20-bit	Use Default	0xFFC00		
	14-bit	Use Delault			
COMPLEX	16-bit		0xFFFFF	0xFFFFF	
DECIMATION	18-bit	1	UXFFFF	UXFFFF	
	20-bit				



	图 8-68. Register 0x24										
7	6	5	4	3	2	1	0				
0	0	CH AVG EN	DDC	MUX	DIG BYP	DDC EN	0				
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0				

### 表 8-31. Register 0x24 Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	R/W	0	Must write 0
5	CH AVG EN	R/W	0	Averages the output of ADC channel A and channel B together. The DDC MUX has to be enabled and set to '11'. The decimation filter needs to be enabled and set to bypass (fullrate output) or decimation and DIG BYP set to 1. 0: Channel averaging feature disabled 1: Output of channel A and channel B are averaged: (A+B)/2.
4-3	DDC MUX	R/W	0	Configures DDC MUX in front of the decimation filter. 00: ADC channel A connected to DDC A; ADC Channel B connected to DDC B 01: ADC channel A connected to DDC A and DDC B. 10: ADC channel B connected to DDC A and DDC B. 11: Output of ADC averaging block (see CH AVG EN) given to DDC A and DDC B.
2	DIG BYP	R/W	0	This bit needs to be set to enable digital features block which includes decimation and scrambling. 0: Digital feature block bypassed - lowest latency 1: Data path includes digital features
1	DDC EN	R/W	0	Enables internal decimation filter for both channels 0: DDC disabled. 1: DDC enabled.
0	0	R/W	0	Must write 0

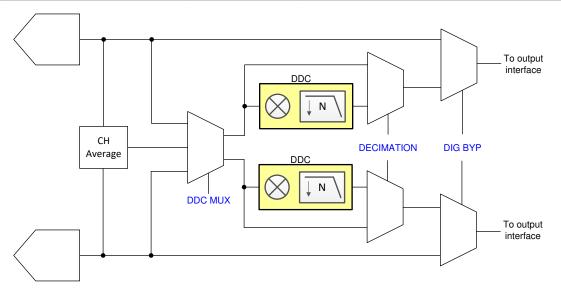


图 8-69. Register control for digital features



#### 图 8-70. Register 0x25

7	6	5 4		3	2	1	0	
DDC MUX EN		DECIMATION		REAL OUT	0	0	MIX PHASE	
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	

### 表 8-32. Register 0x25 Field Descriptions

Bit	Field	Туре	Reset	Description
7	DDC MUX EN	R/W	0	Enables the digital mux between ADCs and decimation filters. This bit is required for DDC mux settings in register 0x24 (D4, D3) to go into effect. 0: DDC mux disabled 1: DDC mux enabled
6-4	DECIMATION	R/W	000	Complex decimation setting. This applies to both channels.
				000: Bypass mode (no decimation)100: Decimation by 16001: Decimation by 2101: Decimation by 32010: Decimation by 4others: not used011: Decimation by 8
3	REAL OUT	R/W	0	This bit selects real output decimation. This mode applies to both channels. In this mode, the decimation filter is a low pass filter and no complex mixing is performed to reduce power consumption. For maximum power savings the NCO in this case should be set to 0. 0: Complex decimation 1: Real decimation
2-1	0	R/W	0	Must write 0
0	MIX PHASE	R/W	0	This bit used to invert the NCO phase 0: NCO phase as is. 1: NCO phase inverted.

# 图 8-71. Register 0x26

7	6	5	4	3	2	1	0
MIX G	SAIN A	MIX RES A	FS/4 MIX A	MIX G	MIX GAIN B		FS/4 MIX B
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

### 表 8-33. Register 0x26 Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	MIX GAIN A	R/W	00	This bit applies a 0, 3 or 6-dB digital gain to the output of digital mixer to compensate for the mixing loss for channel A.00: no digital gain added01: 3-dB digital gain added (should be enabled with real decimation)10: 6-dB digital gain added (should be enabled with complex decimation)11: not used
5	MIX RES A	R/W	0	Toggling this bit resets the NCO phase of channel A and loads the new NCO frequency. This bit does not self reset.
4	FS/4 MIX A	R/W	0	Enables FS/4 mixing for DDC A (complex decimation only). 0: FS/4 mixing disabled. 1: FS/4 mixing enabled.
3-2	MIX GAIN B	R/W	00	This bit applies a 0, 3 or 6-dB digital gain to the output of digital mixer to compensate for the mixing loss for channel B. 00: no digital gain added 01: 3-dB digital gain added (should be enabled with real decimation) 10: 6-dB digital gain added (should be enabled with complex decimation) 11: not used
1	MIX RES B	R/W	0	Toggling this bit resets the NCO phase of channel B and loads the new NCO frequency. This bit does not self reset.



	表 8-33. Register 0x26 Field Descriptions (continued)					
Bit	Bit Field Type Reset Description					
0	FS/4 MIX B	R/W		Enables FS/4 mixing for DDC B (complex decimation only). 0: FS/4 mixing disabled. 1: FS/4 mixing enabled.		

### 图 8-72. Register 0x27

7	6	5	4	3	2	1	0
0	0	0	OP ORDER A	Q-DEL A	FS/4 MIX PH A	0	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

### 表 8-34. Register 0x27 Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	R/W	0	Must write 0
4	OP ORDER A	R/W	0	Swaps the I and Q output order for channel A. See 表 8-35 for recommended settings. Only used with complex decimation. Set to 0 with real decimation. 0: Output order is I[n], Q[n] 1: Output order is swapped: Q[n], I[n]
3	Q-DEL A	R/W	0	This delays the Q-sample output of channel A by one. See 表 8-35 for recommended settings. Only used with complex decimation. Set to 0 with real decimation. 0: Output order is I[n], Q[n] 1: Q-sample is delayed by 1 sample: I[n], Q[n+1], I[n+1], Q[n+2]
2	FS/4 MIX PH A	R/W	0	Inverts the mixer phase for channel A when using FS/4 mixer. 0: Mixer phase is non-inverted 1: Mixer phase is inverted
1-0	0	R/W	0	Must write 0

# 表 8-35. OP-ORDER and Q-DELAY Register Settings for Complex Decimation

SLVDS INTERFACE	OP-ORDER	Q-DELAY
2-wire	1	0
1-wire	0	1
1/2-wire	1	1

### 图 8-73. Register 0x2A/B/C/D

7	7 6 5		4	3	2	1	0				
NCO A [7:0]											
NCO A [15:8]											
	NCO A [23:16]										
	NCO A [31:24]										
R/W-0											

### 表 8-36. Register 0x2A/2B/2C/2D Field Descriptions

Bit	Field	Туре	Reset Description		
7-0	NCO A [31:0]	R/W	-	Sets the 32 bit NCO value for decimation filter channel A. The NCO value is $f_{NCO} \times 2^{32}$ / F <sub>S</sub> . In real decimation mode these registers are automatically set to 0.	



	图 8-74. Register 0x2E										
7	6	5	4	3	2	1	0				
0	0 0 0		OP ORDER B	Q-DEL B	FS/4 MIX PH B	0	0				
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0				

### 表 8-37. Register 0x2E Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	R/W	Must write 0	
4	OP ORDER B	R/W	0	<ul> <li>Swaps the I and Q output order for channel B. See 表 8-35 for recommended settings. Only used with complex decimation. Set to 0 with real decimation.</li> <li>0: Output order is I[n], Q[n]</li> <li>1: Output order is swapped: Q[n], I[n]</li> </ul>
3	Q-DEL B	R/W	0	This delays the Q-sample output of channel B by one. See 表 8-35 for recommended settings. Only used with complex decimation. Set to 0 with real decimation. 0: Output order is I[n], Q[n] 1: Q-sample is delayed by 1 sample: I[n], Q[n+1], I[n+1], Q[n+2]
2	FS/4 MIX PH B	R/W	0	Inverts the mixer phase for channel B when using FS/4 mixer. 0: Mixer phase is non-inverted 1: Mixer phase is inverted
1-0	0	R/W	0	Must write 0

# 图 8-75. Register 0x31/32/33/34

7	7 6 5		4	3	2	1	0			
NCO B [7:0]										
	NCO B [15:8]									
			NCO B	[23:16]						
	NCO B [31:24]									
R/W-0	R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0									

### 表 8-38. Register 0x31/32/33/34 Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	NCO B [31:0]	R/W		Sets the 32 bit NCO value for decimation filter channel B. The NCO value is $f_{NCO} \times 2^{32}$ / F <sub>S</sub> . In real decimation mode these registers are automatically set to 0.

### 图 8-76. Register 0x39..0x60

7	6	5	4	3	2	1	0				
	OUTPUT BIT MAPPER CHA										
R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0											

### 表 8-39. Register 0x39..0x60 Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	OUTPUT BIT MAPPER CHA	R/W	0	These registers are used to reorder the output data bus. See the
				节 8.3.5.3 on how to program it.



	图 8-77. Register 0x610x88										
7 6 5 4 3 2 1 0											
OUTPUT BIT MAPPER CHB											
R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0											

### 表 8-40. Register 0x61..0x88 Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	OUTPUT BIT MAPPER CHB	R/W		These registers are used to reorder the output data bus. See the $\ddagger$ 8.3.5.3 on how to program it.

### 图 8-78. Register 0x8F

7	6	5	4	3	2	1	0
0	0	0	0	0	0	FORMAT A	0
R/W-0	R/W-0						

# 表 8-41. Register 0x8F Field Descriptions

Bit	Field	Туре	Reset	Description		
7-2	0	R/W	0	Must write 0		
1	FORMAT A	R/W		This bit sets the output data format for channel A. Digital bypass register bit (0x24, D2) needs to be enabled as well. 0: 2s complement 1: Offset binary		
0	0	R/W	0	Must write 0		

### 图 8-79. Register 0x92

7	6	5	4	3	2	1	0
0	0	0	0	0	0	FORMAT B	0
R/W-0	R/W-0						

### 表 8-42. Register 0x92 Field Descriptions

······································						
Bit	Field	Туре	Reset	Description		
7-2	0	R/W	0	Must write 0		
1	FORMAT B	R/W	0	This bit sets the output data format for channel B. Digital bypass register bit (0x24, D2) needs to be enabled as well. 0: 2s complement 1: Offset binary		
0	0	R/W	0	Must write 0		



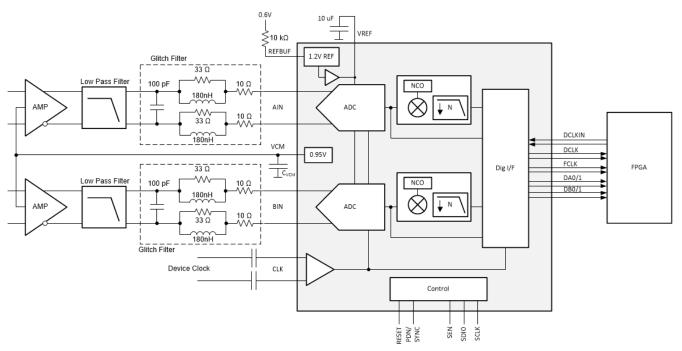
# **9** Application Information Disclaimer

备注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

#### 9.1 Typical Application

A spectrum analyzer is a typical frequency domain application for the ADC368x and its front end circuitry is very similar to several other systems such as software defined radio (SDR), sonar, radar or communications. Some applications require frequency coverage including DC or near DC (such as, sonar), so it is included in this example.





#### 9.1.1 Design Requirements

Frequency domain applications cover a wide range of frequencies from low input frequencies at or near DC in the 1st Nyquist zone to undersampling in higher Nyquist zones. If very low input frequency is supported then the input has to be DC coupled and the ADC driven by a fully differential amplifier (FDA). If low frequency support is not needed then AC coupling and use of a balun may be more suitable.

The internal reference is used since DC precision is not needed. However the ADC AC performance is highly dependent on the quality of the external clock source. If in-band interferers can be present then the ADC SFDR performance will be a key care about as well. A higher ADC sampling rate is desirable in order to relax the external anti-aliasing filter – an internal decimation filter can be used to reduce the digital output rate afterwards.

FEATURE	DESCRIPTION
Signal Bandwidth	DC to 20 MHz
Input Driver	Single ended to differential signal conversion and DC coupling

#### 表 9-1. Design key care-abouts

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表 9-1. Design key care-abouts (continued)						
FEATURE	DESCRIPTION					
Clock Source	External clock with low jitter					

When designing the amplifier/filter driving circuit, the ADC input full-scale voltage needs to be taken into consideration. For example, the ADC368x input full-scale is 3.2 Vpp. When factoring in  $\sim$  1 dB for insertion loss of the filter, then the amplifier needs to deliver close to 3.6 Vpp. The amplifier distortion performance will degrade with a larger output swing and considering the ADC common mode input voltage the amplifier may not be able to deliver the full swing. The ADC368x provides an output common mode voltage of 0.95V and the THS4541 for example can only swing within 250 mV of its negative supply. A unipolar 3.3 V amplifier power supply will thus limit the maximum voltage swing to  $\sim$  2.8 Vpp. Hence if a larger output swing is required (factoring in filter insertion loss) then a negative supply for the amplifier is needed in order to eliminate that limitation. Additionally input voltage protection diodes may be needed to protect the ADC from over-voltage events.

### 表 9-2. Output voltage swing of THS4541 vs power supply

DEVICE	MIN OUTPUT VOLTAGE	MAX SWING WITH 3.3 V/ 0 V SUPPLY	MAX SWING WITH 3.3 V/ -1.0 V SUPPLY
THS4541	VS- + 250 mV	2.8 Vpp	6.8 Vpp

#### 9.1.2 Detailed Design Procedure

#### 9.1.2.1 Input Signal Path

Depending on desired input signal frequency range the THS4551 and THS4541 provide very good low power options to drive the ADC inputs.  $\frac{1}{2}$  9-3 provides a comparison between the THS4551 and THS4541 and the power consumption vs usable frequency trade off.

DEVICE	CURRENT (IQ) PER CHANNEL	USABLE FREQUENCY RANGE
THS4561	0.8 mA	< 3 MHz
THS4551	1.4 mA	< 10 MHz
THS4541	10 mA	< 70 MHz

#### 表 9-3. Fully Differential Amplifier Options

The low pass filter design (topology, filter order) is driven by the application itself. However, when designing the low pass filter, the optimum load impedance for the amplifier should be taken into consideration as well. Between the low pass filter and the ADC input the sampling glitch filter needs to added as well as shown in  $\ddagger 8.3.1.2.1$ . In this example the DC - 30 MHz glitch filter is selected.

#### 9.1.2.2 Sampling Clock

Applications operating with low input frequencies (such as DC to 20 MHz) typically are less sensitive to performance degradation due to clock jitter. The internal ADC aperture jitter improves with faster rise and fall times (i.e. square wave vs sine wave).  $\gtrsim$  9-4 provides an overview of the estimated SNR performance of the ADC368x based on different amounts of jitter of the external clock source. The SNR is estimated based on ADC368x thermal noise of 84.2dBFS and input signal at -1dBFS.

#### 表 9-4. ADC SNR performance across vs input frequency for different amounts of external clock jitter

•		<u> </u>		
INPUT FREQUENCY	T <sub>J,EXT</sub> = 100 fs	T <sub>J,EXT</sub> = 250 fs	T <sub>J,EXT</sub> = 500 fs	T <sub>J,EXT</sub> = 1 ps
5 MHz	84.2	84.1	83.9	83.4
10 MHz	84.0	83.9	83.3	81.5
20 MHz	83.6	83.0	81.3	77.8

Termination of the clock input should be considered for long clock traces.

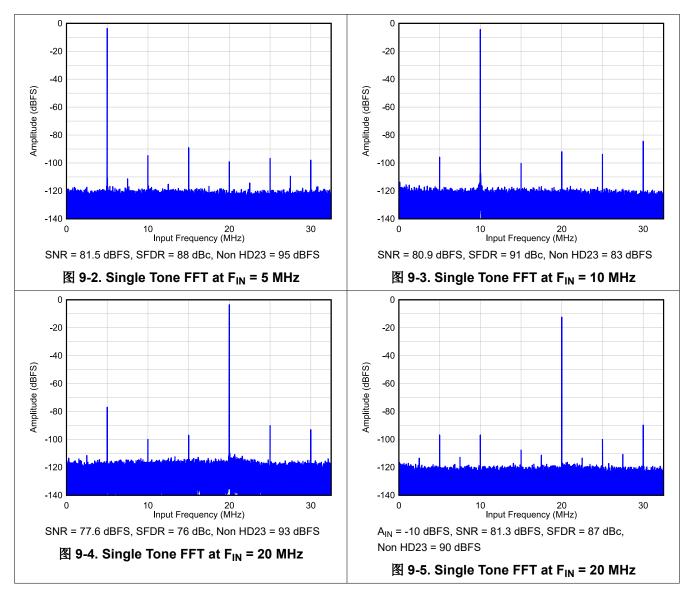
#### 9.1.2.3 Voltage Reference

The ADC368x is configured to internal reference operation by applying 0.6 V to the REFBUF pin.



### 9.1.3 Application Curves

The following FFT plots show the performance of THS4541 driving the ADC3683 operated at 65 MSPS with a full-scale input at -1 dBFS and input frequencies of 5, 10 and 20 MHz.





# 9.2 Initialization Set Up

After power-up, the internal registers must be initialized to their default values through a hardware reset by applying a high pulse on the RESET pin, as shown in [8] 9-6.

- 1. Apply AVDD and IOVDD (no specific sequence required). After AVDD is applied the internal bandgap reference will power up and settle out in ~ 2ms.
- 2. Configure REFBUF pin (pull high or low even if configured via SPI later on) and apply the sampling clock.
- 3. Apply hardware reset. After hardware reset is released, the default registers are loaded from internal fuses and the internal power up capacitor calibration is initiated. The calibration takes approximately 200000 clock cycles.
- 4. Begin programming using SPI interface.

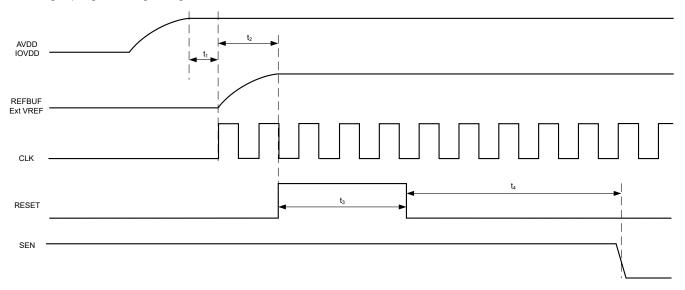


图 9-6. Initialization of serial registers after power up

		MIN	TYP	MAX	UNIT						
t <sub>1</sub>	Power-on delay: delay from power up to logic level of REFBUF pin	2			ms						
t <sub>2</sub>	Delay from REFBUF pin logic level to RESET rising edge	100			ns						
t <sub>3</sub>	RESET pulse width	1			us						
t <sub>4</sub>	Delay from RESET disable to SEN active	~ 200000			clock cycles						

#### 表 9-5. Power-up timing

#### 9.2.1 Register Initialization During Operation

If required, the serial interface registers can be cleared and reset to default settings during operation either:

- through a hardware reset or
- by applying a software reset. When using the serial interface, set the RESET bit (D0 in register address 0x00) high. This setting initializes the internal registers to the default values and then self-resets the RESET bit low. In this case, the RESET pin is kept low.

After hardware or software reset the wait time is also ~ 200000 clock cycles before the SPI registers can be programmed.



#### 9.3 Power Supply Recommendations

The ADC368x requires two different power-supplies. The AVDD rail provides power for the internal analog circuits and the ADC itself while the IOVDD rail powers the digital interface and the internal digital circuits like decimation filter or output interface mapper. Power sequencing is not required.

The AVDD power supply must be low noise in order to achieve data sheet performance. In applications operating near DC, the 1/f noise contribution of the power supply needs to be considered as well. The ADC is designed for very good PSRR which aides with the power supply filter design.

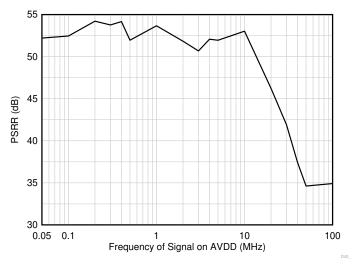


图 9-7. Power supply rejection ratio (PSRR) vs frequency

There are two recommended power-supply architectures:

- 1. 1. Step down using high-efficiency switching converters, followed by a second stage of regulation using a low noise LDO to provide switching noise reduction and improved voltage accuracy.
- 2. 2. Directly step down the final ADC supply voltage using high-efficiency switching converters. This approach provides the best efficiency, but care must be taken to ensure switching noise is minimized to prevent degraded ADC performance.

TI WEBENCH® Power Designer can be used to select and design the individual power-supply elements needed: see the WEBENCH® Power Designer

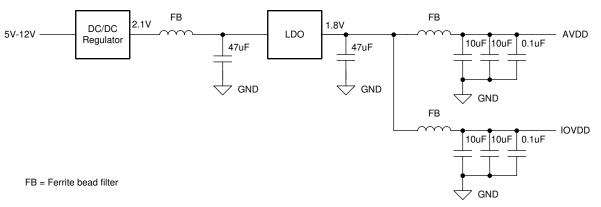
Recommended switching regulators for the first stage include the TPS62821, and similar devices.

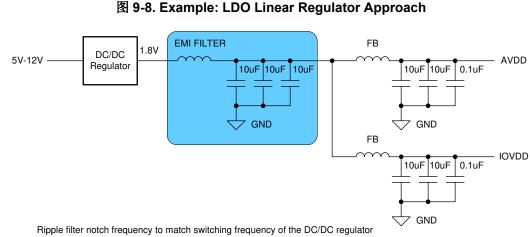
Recommended low dropout (LDO) linear regulators include the TPS7A4701, TPS7A90, LP5901, and similar devices.

For the switch regulator only approach, the ripple filter must be designed with a notch frequency that aligns with the switching ripple frequency of the DC/DC converter. Note the switching frequency reported from WEBENCH® and design the EMI filter and capacitor combination to have the notch frequency centered as needed.  $\boxed{8}$  9-8 and  $\boxed{8}$  9-9 illustrate the two approaches.

AVDD and IOVDD supply voltages should not be shared in order to prevent digital switching noise from coupling into the analog signal chain.







FB = Ferrite bead filter

### 图 9-9. Example Switcher-Only Approach

### 9.4 Layout

#### 9.4.1 Layout Guidelines

There are several critical signals which require specific care during board design:

- 1. Analog input and clock signals
  - Traces should be as short as possible and vias should be avoided where possible to minimize impedance • discontinuities.
  - Traces should be routed using loosely coupled 100- $\Omega$  differential traces.
  - Differential trace lengths should be matched as close as possible to minimize phase imbalance and HD2 degradation.
- 2. Digital output interface
  - Traces should be routed using tightly coupled 100-Ω differential traces.
- 3. Voltage reference
  - The bypass capacitor should be placed as close to the device pins as possible and connected between VREF and REFGND - on top layer avoiding vias.
  - Depending on configuration an additional bypass capacitor between REFBUF and REFGND may be recommended and should also be placed as close to pins as possible on top layer.
- 4. Power and ground connections
  - Provide low resistance connection paths to all power and ground pins. •
  - Use power and ground planes instead of traces.
  - · Avoid narrow, isolated paths which increase the connection resistance.



• Use a signal/ground/power circuit board stackup to maximize coupling between the ground and power plane.

#### 9.4.2 Layout Example

The following screen shot shows the top layer of the ADC368x EVM.

- Signal and clock inputs are routed as differential signals on the top layer avoiding vias.
- SLVDS output interface lanes are routed differential and length matched
- Bypass caps are close to the VREF pin on the top layer avoiding vias.

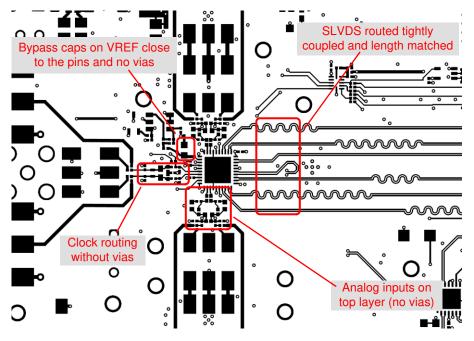


图 9-10. Layout example: top layer of ADC368x EVM



# 10 Device and Documentation Support

### 10.1 接收文档更新通知

要接收文档更新通知,请导航至 ti.com 上的器件产品文件夹。点击*订阅更新*进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

### 10.2 支持资源

TI E2E<sup>™</sup> 支持论坛是工程师的重要参考资料,可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解 答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者"按原样"提供。这些内容并不构成 TI 技术规范,并且不一定反映 TI 的观点;请参阅 TI 的《使用条款》。

### 10.3 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

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#### **10.4 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.5 术语表

TI 术语表 本术语表列出并解释了术语、首字母缩略词和定义。

### 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



# PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	Package	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
ADC3681IRSBR	ACTIVE	WQFN	RSB	40	3000	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3681	Samples
ADC3681IRSBT	ACTIVE	WQFN	RSB	40	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3681	Samples
ADC3682IRSBR	ACTIVE	WQFN	RSB	40	3000	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3682	Samples
ADC3682IRSBT	ACTIVE	WQFN	RSB	40	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3682	Samples
ADC3683IRSBR	ACTIVE	WQFN	RSB	40	3000	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3683	Samples
ADC3683IRSBT	ACTIVE	WQFN	RSB	40	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3683	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



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Texas

STRUMENTS

### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADC3681IRSBR	WQFN	RSB	40	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2
ADC3682IRSBR	WQFN	RSB	40	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2
ADC3683IRSBR	WQFN	RSB	40	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2



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# PACKAGE MATERIALS INFORMATION

5-Dec-2023



\*All dimensions are nominal

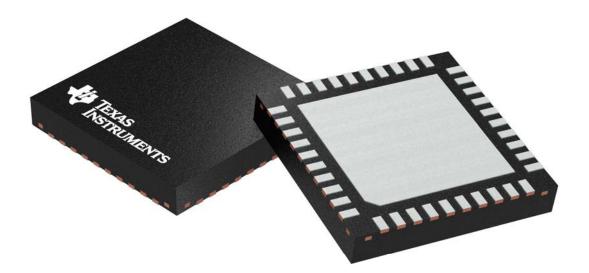
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADC3681IRSBR	WQFN	RSB	40	3000	350.0	350.0	43.0
ADC3682IRSBR	WQFN	RSB	40	3000	350.0	350.0	43.0
ADC3683IRSBR	WQFN	RSB	40	3000	350.0	350.0	43.0

# **RSB 40**

5 x 5 mm, 0.4 mm pitch

# **GENERIC PACKAGE VIEW**

# WQFN - 0.8 mm max height PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



4207182/D

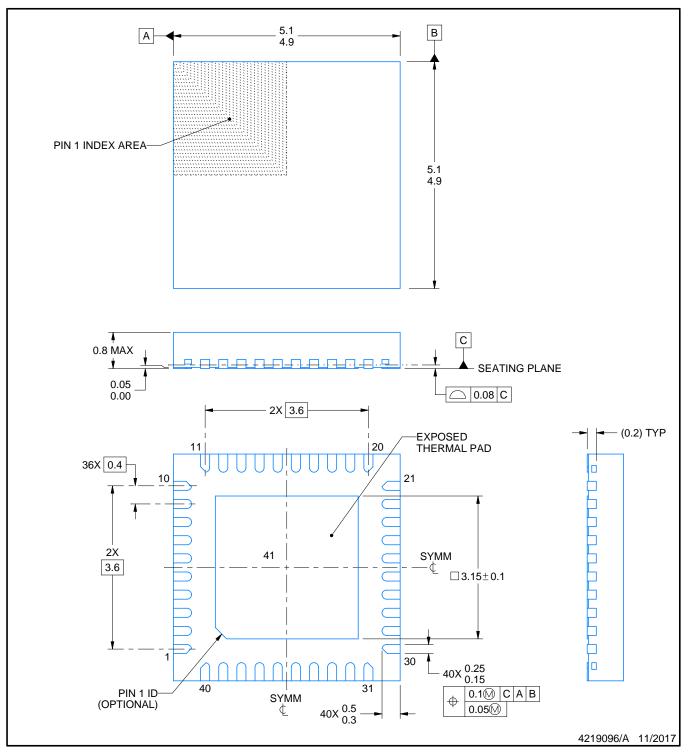
# **RSB0040E**



# **PACKAGE OUTLINE**

# WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

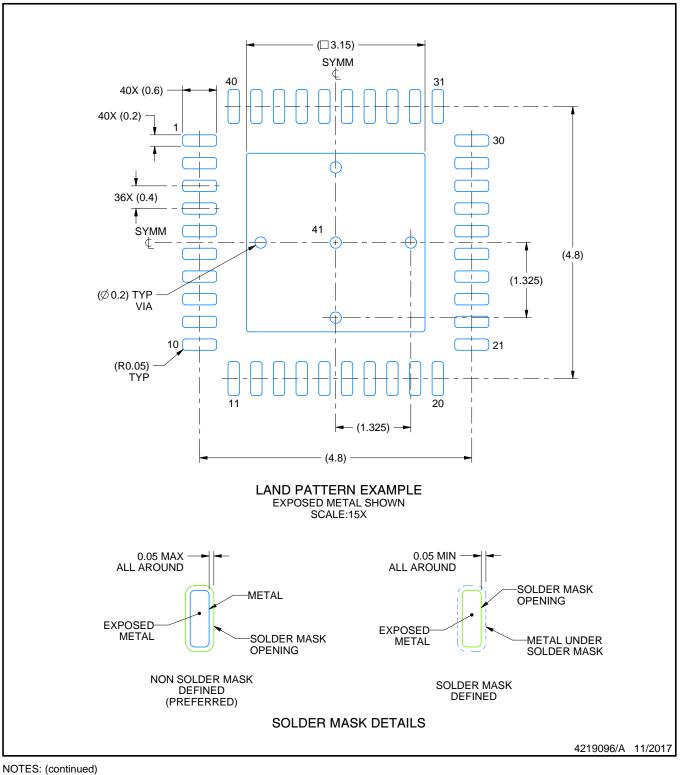


# **RSB0040E**

# **EXAMPLE BOARD LAYOUT**

# WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

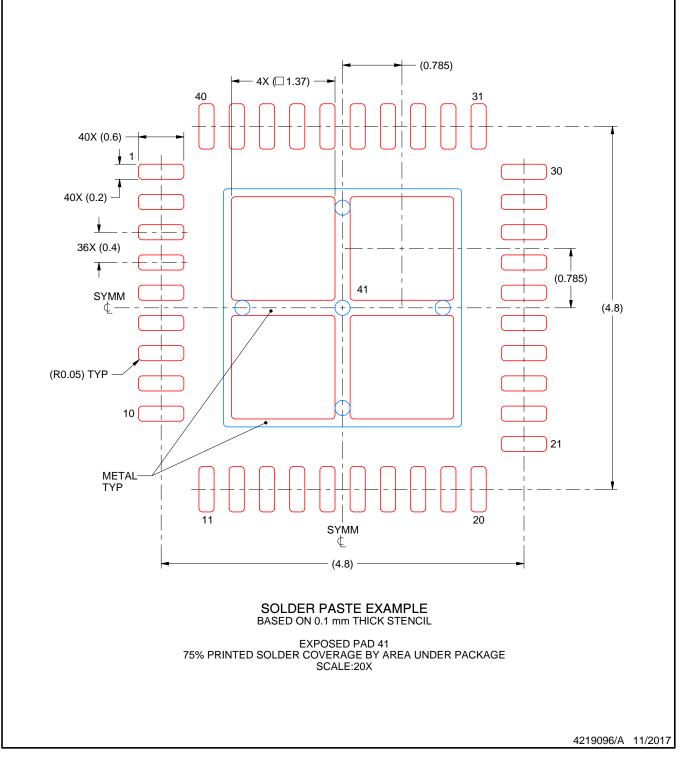


# **RSB0040E**

# **EXAMPLE STENCIL DESIGN**

# WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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